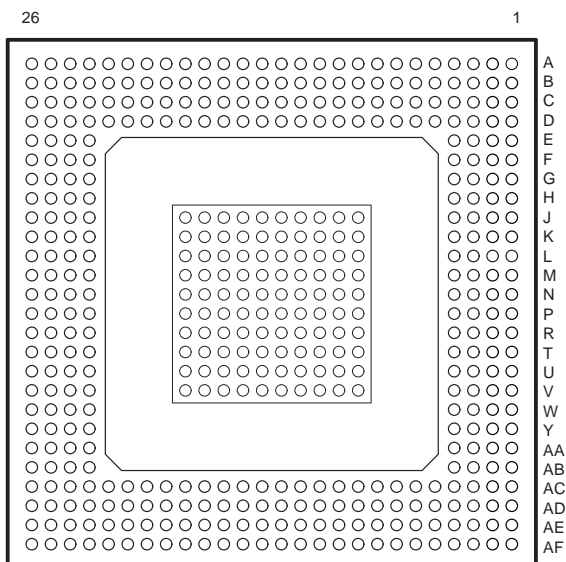


- **Highest Performance Floating-Point Digital Signal Processor (DSP) TMX320C6701**
 - 6-ns Instruction Cycle Time
 - 167-MHz Clock Rate
 - Eight 32-Bit Instructions/Cycle
 - 1 GFLOPS
 - Pin-Compatible With 'C6201 Fixed-Point DSP
- **VelociTI™ Advanced Very Long Instruction Word (VLIW) 'C67x CPU Core**
 - Eight Highly Independent Functional Units:
 - Four ALUs (Floating- and Fixed-Point)
 - Two ALUs (Fixed-Point)
 - Two Multipliers (Floating- and Fixed-Point)
 - Load-Store Architecture With 32 32-Bit General-Purpose Registers
 - Instruction Packing Reduces Code Size
 - All Instructions Conditional
- **Instruction Set Features**
 - Hardware Support for IEEE Single-Precision Instructions
 - Hardware Support for IEEE Double-Precision Instructions
 - Byte-Addressable (8-, 16-, 32-Bit Data)
 - 32-Bit Address Range
 - 8-Bit Overflow Protection
 - Saturation
 - Bit-Field Extract, Set, Clear
 - Bit-Counting
 - Normalization
- **1M-Bit On-Chip SRAM**
 - 512K-Bit Internal Program/Cache (16K 32-Bit Instructions)
 - 512K-Bit Dual-Access Internal Data (64K Bytes)
- **32-Bit External Memory Interface (EMIF)**
 - Glueless Interface to Synchronous Memories: SDRAM and SBSRAM
 - Glueless Interface to Asynchronous Memories: SRAM and EPROM
- **Four-Channel Bootloading Direct-Memory-Access (DMA) Controller With an Auxiliary Channel**

**GJC (452-PIN BGA) PACKAGE†
(BOTTOM VIEW)**



† A 100-pin central 10 × 10 grid is present for thermal dissipation and should be connected to GND.

- **16-Bit Host-Port Interface (HPI)**
 - Access to Entire Memory Map
- **Two Multichannel Buffered Serial Ports (McBSPs)**
 - Direct Interface to T1/E1, MVIP, SCSA Framers
 - ST-Bus-Switching Compatible
 - Up to 256 Channels Each
 - AC97-Compatible
 - Serial-Peripheral-Interface (SPI) Compatible (Motorola™)
- **Two 32-Bit General-Purpose Timers**
- **Flexible Phase-Locked-Loop (PLL) Clock Generator**
- **IEEE-1149.1 (JTAG‡) Boundary-Scan-Compatible**
- **452-Pin Ball Grid Array (BGA) Package (GJC Suffix)**
- **0.18-μm/5-Level Metal Process**
 - CMOS Technology
- **3.3-V I/Os, 1.8-V Internal**



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‡ IEEE Standard 1149.1-1990 Standard-Test-Access Port and Boundary Scan Architecture.

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ADVANCE INFORMATION

TMX320C6701

FLOATING-POINT DIGITAL SIGNAL PROCESSOR

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Signal Descriptions

SIGNAL NAME	NO.	TYPE†	DESCRIPTION
CLOCK/PLL			
CLKIN	C10	I	Clock Input
CLKOUT1	AF22	O	Clock output at full device speed
CLKOUT2	AF20	O	Clock output at half of device speed
CLKMODE1	C6	I	Clock mode select
CLKMODE0	C5		<ul style="list-style-type: none"> Selects whether the output clock frequency = input clock frequency x4 or x1
PLLREQ3	A9	I	PLL frequency range (3, 2, and 1) <ul style="list-style-type: none"> The target range for CLKOUT1 frequency is determined by the 3-bit value of the PLLREQ pins.
PLLREQ2	D11		
PLLREQ1	B10		
PLL‡	D12	A§	PLL analog V _{CC} connection for the low-pass filter
PLL‡	C12	A§	PLL analog GND connection for the low-pass filter
PLLF	A11	A§	PLL low-pass filter connection to external components and a bypass capacitor
JTAG EMULATION			
TMS	L3	I	JTAG test-port mode select (features an internal pullup)
TDO	W2	O/Z	JTAG test-port data out
TDI	R4	I	JTAG test-port data in (features an internal pullup)
TCK	R3	I	JTAG test-port clock
TRST	T1	I	JTAG test-port reset (features an internal pulldown)
EMU1	Y1	I/O/Z	Emulation pin 1, pullup with a dedicated 20-kΩ resistor
EMU0	W3	I/O/Z	Emulation pin 0, pullup with a dedicated 20-kΩ resistor
CONTROL			
RESET	K2	I	Device reset
NMI	L2	I	Nonmaskable interrupt <ul style="list-style-type: none"> Edge-driven (rising edge)
EXT_INT7	U3	I	External interrupts <ul style="list-style-type: none"> Edge-driven (rising edge)
EXT_INT6	V2		
EXT_INT5	W1		
EXT_INT4	U4		
IACK	Y2	O	Interrupt acknowledge for all active interrupts serviced by the CPU
INUM3	AA1	O	Active interrupt identification number <ul style="list-style-type: none"> Valid during IACK for all active interrupts (not just external) Encoding order follows the interrupt-service fetch-packet ordering
INUM2	W4		
INUM1	AA2		
INUM0	AB1		
LENDIAN	H3	I	If high, LENDIAN selects little-endian byte/half-word addressing order within a word If low, LENDIAN selects big-endian addressing
PD	D3	O	Power-down mode 3 (active if high)

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‡ PLLV and PLLG are not part of external voltage supply or ground. See the CLOCK/PLL documentation for information on how to connect these pins.

§ A = Analog Signal (PLL Filter)

Signal Descriptions (Continued)

SIGNAL NAME	NO.	TYPE†	DESCRIPTION
HOST-PORT INTERFACE (HPI)			
$\overline{\text{HINT}}$	H26	O/Z	Host interrupt (from DSP to host)
HCNTL1	F23	I	Host control – selects between control, address, or data registers
HCNTL0	D25	I	Host control – selects between control, address, or data registers
HHWIL	C26	I	Host half-word select – first or second half-word (not necessarily high or low order)
HBE1	E23	I	Host byte select within word or half-word
HBE0	D24	I	Host byte select within word or half-word
HR/W	C23	I	Host read or write select
HD15	B13	I/O/Z	Host-port data (used for transfer of data, address, and control)
HD14	B14		
HD13	C14		
HD12	B15		
HD11	D15		
HD10	B16		
HD9	A17		
HD8	B17		
HD7	D16		
HD6	B18		
HD5	A19		
HD4	C18		
HD3	B19		
HD2	C19		
HD1	B20		
HD0	B21		
$\overline{\text{HAS}}$	C22	I	Host address strobe
$\overline{\text{HCS}}$	B23	I	Host chip select
$\overline{\text{HDS1}}$	D22	I	Host data strobe 1
$\overline{\text{HDS2}}$	A24	I	Host data strobe 2
HRDY	J24	O	Host ready (from DSP to host)
BOOT MODE			
BOOTMODE4	D8	I	Boot mode
BOOTMODE3	B4		
BOOTMODE2	A3		
BOOTMODE1	D5		
BOOTMODE0	C4		

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Signal Descriptions (Continued)

SIGNAL NAME		NO.	TYPE†	DESCRIPTION
EMIF – CONTROL SIGNALS COMMON TO ALL TYPES OF MEMORY				
$\overline{\text{CE3}}$	AE22	O/Z	Memory space enables <ul style="list-style-type: none">Enabled by bits 24 and 25 of the word addressOnly one asserted during any external data access	
$\overline{\text{CE2}}$	AD26	O/Z		
$\overline{\text{CE1}}$	AB24	O/Z		
$\overline{\text{CE0}}$	AC26	O/Z		
$\overline{\text{BE3}}$	AB25	O/Z	Byte-enable control <ul style="list-style-type: none">Decoded from the two lowest bits of the internal addressByte-write enables for most types of memoryCan be directly connected to SDRAM read and write mask signal (SDQM)	
$\overline{\text{BE2}}$	AA24	O/Z		
$\overline{\text{BE1}}$	Y23	O/Z		
$\overline{\text{BE0}}$	AA26	O/Z		
EMIF – ADDRESS				
EA21	J26	O/Z	External address (word address)	
EA20	K25			
EA19	L24			
EA18	K26			
EA17	M26			
EA16	M25			
EA15	P25			
EA14	P24			
EA13	R25			
EA12	T26			
EA11	R23			
EA10	U26			
EA9	U25			
EA8	T23			
EA7	V26			
EA6	V25			
EA5	W26			
EA4	V24			
EA3	W25			
EA2	Y26			

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Signal Descriptions (Continued)

SIGNAL NAME NO.		TYPE†	DESCRIPTION
EMIF – DATA			
ED31	AB2	I/O/Z	External data
ED30	AC1		
ED29	AA4		
ED28	AD1		
ED27	AC3		
ED26	AD4		
ED25	AF3		
ED24	AE4		
ED23	AD5		
ED22	AF4		
ED21	AE5		
ED20	AD6		
ED19	AE6		
ED18	AD7		
ED17	AC8		
ED16	AF7		
ED15	AD9		
ED14	AD10		
ED13	AF9		
ED12	AC11		
ED11	AE10		
ED10	AE11		
ED9	AF11		
ED8	AE14		
ED7	AF15		
ED6	AE15		
ED5	AF16		
ED4	AC15		
ED3	AE17		
ED2	AF18		
ED1	AF19		
ED0	AC17		
EMIF – ASYNCHRONOUS MEMORY CONTROL			
$\overline{\text{ARE}}$	Y24	O/Z	Asynchronous memory read enable
$\overline{\text{AOE}}$	AC24	O/Z	Asynchronous memory output enable
$\overline{\text{AWE}}$	AD23	O/Z	Asynchronous memory write enable
ARDY	W23	I	Asynchronous memory ready input

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Signal Descriptions (Continued)

SIGNAL NAME		NO.	TYPE†	DESCRIPTION
EMIF – SYNCHRONOUS BURST SRAM CONTROL				
SSADS	AC20	O/Z	SBSRAM address strobe	
SSOE	AF21	O/Z	SBSRAM output enable	
SSWE	AD19	O/Z	SBSRAM write enable	
SSCLK	AD17	O/Z	SBSRAM clock	
EMIF – SYNCHRONOUS DRAM CONTROL				
SDA10	AD21	O/Z	SDRAM address 10 (separate for deactivate command)	
SDRAS	AF24	O/Z	SDRAM row-address strobe	
SDCAS	AD22	O/Z	SDRAM column-address strobe	
SDWE	AF23	O/Z	SDRAM write enable	
SDCLK	AE20	O/Z	SDRAM clock	
EMIF – BUS ARBITRATION				
HOLD	AA25	I	Hold request from the host	
HOLDA	A7	O	Hold-request-acknowledge to the host	
TIMERS				
TOUT1	H24	O/Z	Timer 1 or general-purpose output	
TINP1	K24	I	Timer 1 or general-purpose input	
TOUT0	M4	O/Z	Timer 0 or general-purpose output	
TINP0	K4	I	Timer 0 or general-purpose input	
DMA ACTION COMPLETE				
DMAC3	D2	O	DMA action complete	
DMAC2	F4			
DMAC1	D1			
DMAC0	E2			
MULTICHANNEL BUFFERED SERIAL PORT 1 (McBSP1)				
CLKS1	E25	I	External clock source (as opposed to internal)	
CLKR1	H23	I/O/Z	Receive clock	
CLKX1	F26	I/O/Z	Transmit clock	
DR1	D26	I	Receive data	
DX1	G23	O/Z	Transmit data	
FSR1	E26	I/O/Z	Receive frame sync	
FSX1	F25	I/O/Z	Transmit frame sync	

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Signal Descriptions (Continued)

SIGNAL NAME	NO.	TYPE†	DESCRIPTION
MULTICHANNEL BUFFERED SERIAL PORT 0 (McBSP0)			
CLKS0	L4	I	External clock source (as opposed to internal)
CLKR0	M2	I/O/Z	Receive clock
CLKX0	L1	I/O/Z	Transmit clock
DR0	J1	I	Receive data
DX0	R1	O/Z	Transmit data
FSR0	P4	I/O/Z	Receive frame sync
FSX0	P3	I/O/Z	Transmit frame sync
RESERVED FOR TEST			
RSV0	T2	I	Reserved for testing, pullup with a dedicated 20-kΩ resistor
RSV1	G2	I	Reserved for testing, pullup with a dedicated 20-kΩ resistor
RSV2	C11	I	Reserved for testing, pullup with a dedicated 20-kΩ resistor
RSV3	B9	I	Reserved for testing, pullup with a dedicated 20-kΩ resistor
RSV4	A6	I	Reserved for testing, pulldown with a dedicated 20-kΩ resistor
RSV5	C8	O	Reserved (leave unconnected, do not connect to power or ground)
RSV6	C21	I	Reserved for testing, pullup with a dedicated 20-kΩ resistor
RSV7	B22	I	Reserved for testing, pullup with a dedicated 20-kΩ resistor
RSV8	A23	I	Reserved for testing, pullup with a dedicated 20-kΩ resistor
SUPPLY VOLTAGE PINS			
DV _{DD}	A10	S	3.3-V supply voltage
	A15		
	A18		
	A21		
	A22		
	B7		
	C1		
	D17		
	F3		
	G24		
	G25		
	H25		
	J25		
	L25		
	M3		
	N3		
	N23		
	R26		
	T24		
	U24		
	W24		

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Signal Descriptions (Continued)

SIGNAL NAME NO.		TYPE†	DESCRIPTION
SUPPLY VOLTAGE PINS (CONTINUED)			
DVDD	Y4	S	3.3-V supply voltage
	AB3		
	AB4		
	AB26		
	AC6		
	AC10		
	AC19		
	AC21		
	AC22		
	AC25		
	AD11		
	AD13		
	AD15		
	AD18		
	AE18		
	AE21		
	AF5		
	AF6		
	AF17		
CVDD	A5	S	1.8-V supply voltage
	A12		
	A16		
	A20		
	B2		
	B6		
	B11		
	B12		
	B25		
	C3		
	C15		
	C20		
	C24		
	D4		
	D6		
	D7		
	D9		
	D14		
	D18		
	D20		

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Signal Descriptions (Continued)

SIGNAL NAME NO.		TYPE†	DESCRIPTION
SUPPLY VOLTAGE PINS (CONTINUED)			
CVDD	D23	S	1.8-V supply voltage
	E1		
	F1		
	H4		
	J4		
	J23		
	K1		
	K23		
	M1		
	M24		
	N4		
	N25		
	P2		
	P23		
	T3		
	T4		
	U1		
	V4		
	V23		
	AC4		
	AC9		
	AC12		
	AC13		
	AC18		
	AC23		
	AD3		
	AD8		
	AD14		
	AD24		
	AE2		
	AE8		
	AE12		
	AE25		
	AF12		

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Signal Descriptions (Continued)			
SIGNAL NAME NO.		TYPE†	DESCRIPTION
GROUND PINS			
VSS	A1	GND	Ground pins
	A2		
	A4		
	A13		
	A14		
	A25		
	A26		
	B1		
	B3		
	B5		
	B24		
	B26		
	C2		
	C7		
	C13		
	C16		
	C17		
	C25		
	D13		
	D19		
	E3		
	E24		
	F2		
	F24		
	G3		
	G4		
	G26		
	J3		
	L23		
	L26		
	M23		
	N1		
	N2		
	N24		
	N26		
	P1		
	P26		
	R24		
	T25		

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Signal Descriptions (Continued)

SIGNAL NAME NO.		TYPE†	DESCRIPTION
GROUND PINS (CONTINUED)			
VSS	U2	GND	Ground pins
	U23		
	V1		
	V3		
	Y3		
	Y25		
	AA3		
	AA23		
	AB23		
	AC2		
	AC5		
	AC7		
	AC14		
	AC16		
	AD2		
	AD12		
	AD16		
	AD20		
	AD25		
	AE1		
	AE3		
	AE7		
	AE9		
	AE13		
	AE16		
	AE19		
	AE23		
	AE24		
	AE26		
	AF1		
	AF2		
	AF8		
	AF10		
	AF13		
	AF14		
	AF25		
	AF26		

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Signal Descriptions (Continued)

SIGNAL NAME NO.		TYPE†	DESCRIPTION
THERMAL DISSIPATION PINS			
THB	J9		Thermal dissipation pins. The THB pins make up a central 10 x 10 grid array and should be connected to GND.
	J10		
	J11		
	J12		
	J13		
	J14		
	J15		
	J16		
	J17		
	J18		
	K9		
	K10		
	K11		
	K12		
	K13		
	K14		
	K15		
	K16		
	K17		
	K18		
	L9		
	L10		
	L11		
	L12		
	L13		
	L14		
	L15		
	L16		
	L17		
	L18		
	M9		
	M10		
	M11		
	M12		
	M13		
	M14		
	M15		
	M16		

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Signal Descriptions (Continued)

SIGNAL NAME NO.		TYPE†	DESCRIPTION
THERMAL DISSIPATION PINS (CONTINUED)			
THB	M17		Thermal dissipation pins. The THB pins make up a central 10 x 10 grid array and should be connected to GND.
	M18		
	N9		
	N10		
	N11		
	N12		
	N13		
	N14		
	N15		
	N16		
	N17		
	N18		
	P9		
	P10		
	P11		
	P12		
	P13		
	P14		
	P15		
	P16		
	P17		
	P18		
	R9		
	R10		
	R11		
	R12		
	R13		
	R14		
	R15		
	R16		
	R17		
	R18		
	T9		
	T10		
	T11		
	T12		
	T13		
	T14		

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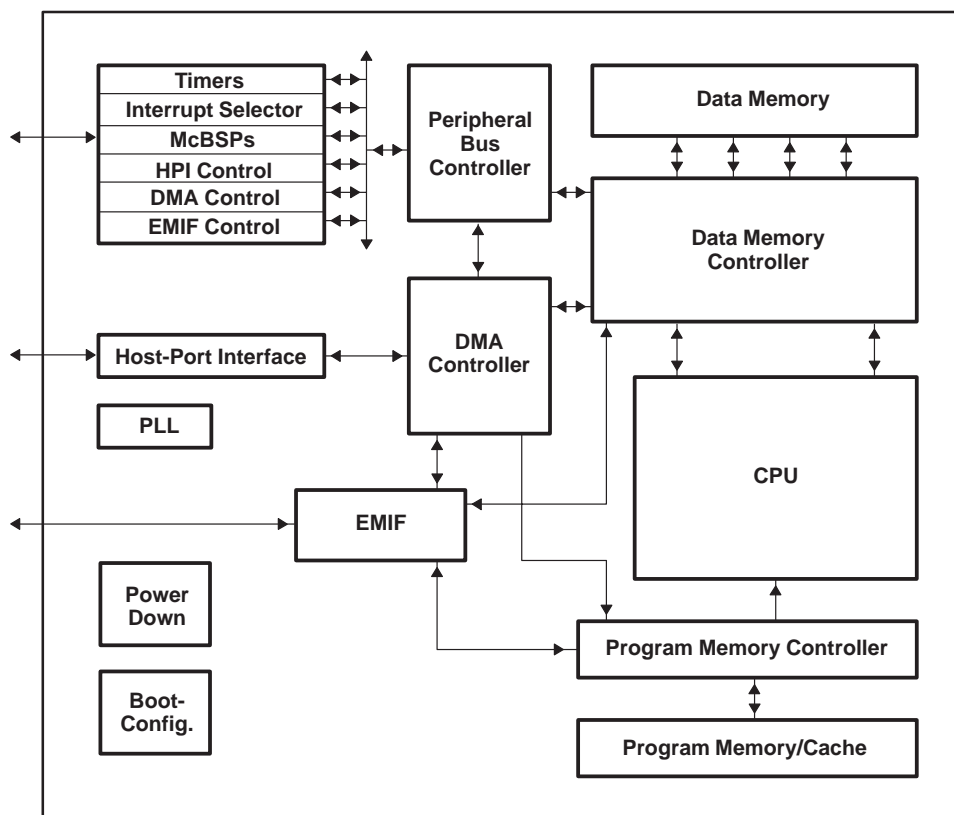
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Signal Descriptions (Continued)			
SIGNAL NAME NO.		TYPE†	DESCRIPTION
THERMAL DISSIPATION PINS (CONTINUED)			
THB	T15		Thermal dissipation pins. The THB pins make up a central 10 x 10 grid array and should be connected to GND.
	T16		
	T17		
	T18		
	U9		
	U10		
	U11		
	U12		
	U13		
	U14		
	U15		
	U16		
	U17		
	U18		
	V9		
	V10		
	V11		
	V12		
	V13		
	V14		
V15			
V16			
V17			
V18			
REMAINING UNCONNECTED PINS			
NC	A8		Unconnected pins
	B8		
	C9		
	D10		
	D21		
	E4		
	G1		
	H1		
	H2		
	J2		
	K3		
	R2		

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functional block diagram



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signal groups

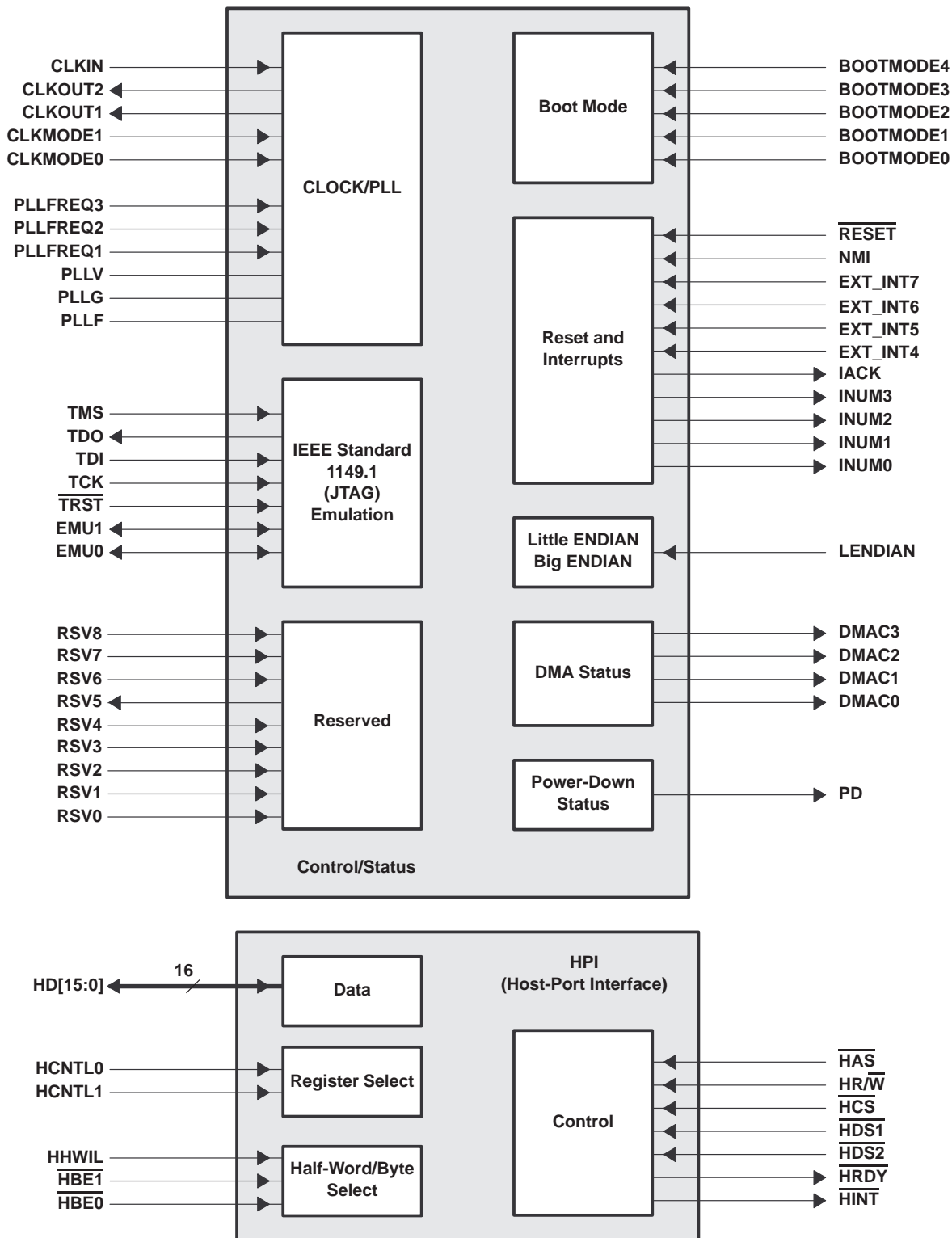


Figure 1. CPU and Peripheral Signals

signal groups (continued)

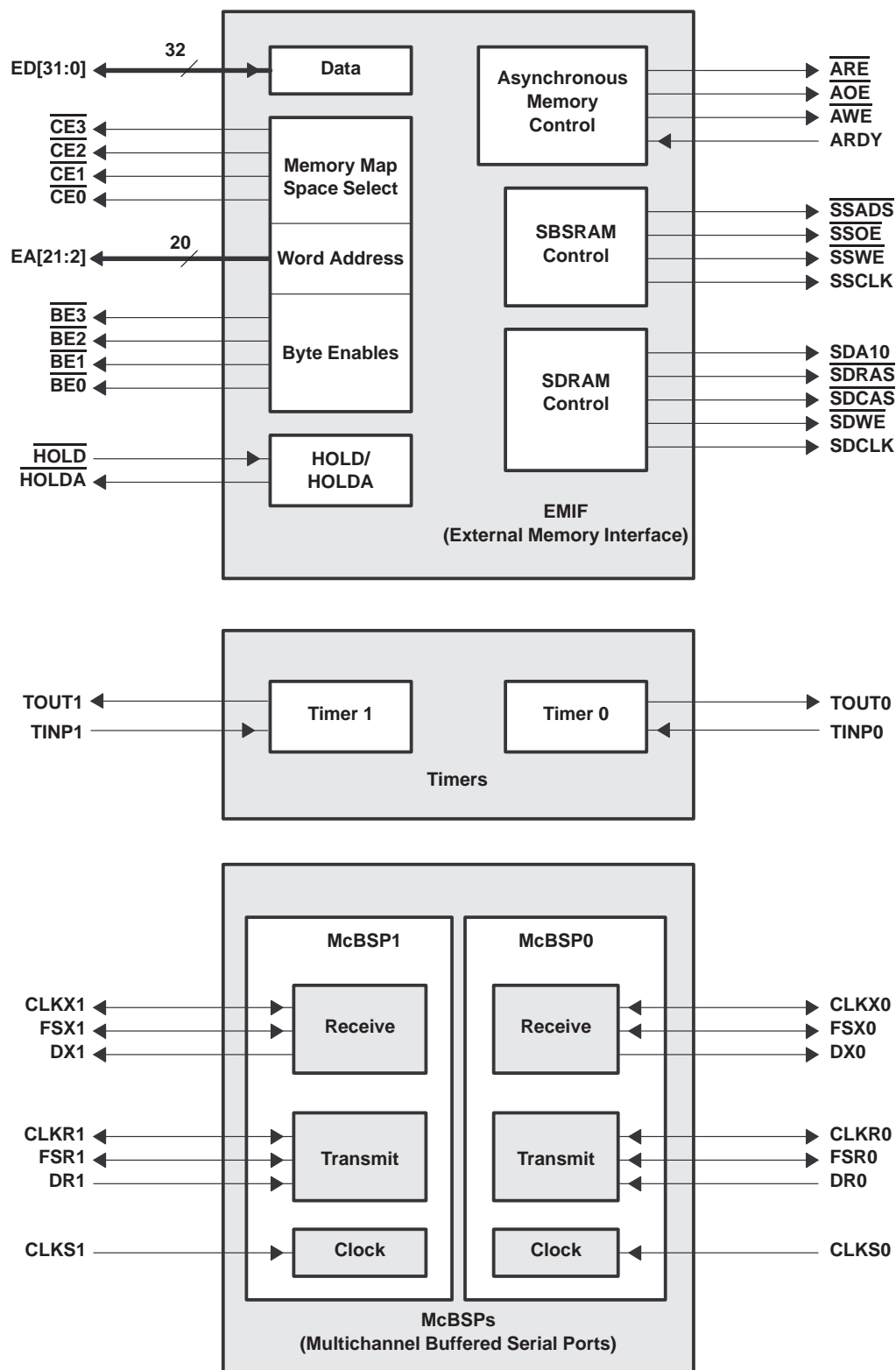


Figure 2. Peripheral Signals

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FLOATING-POINT DIGITAL SIGNAL PROCESSOR

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CPU description

The CPU fetches VelociTI advanced very-long instruction words (VLIW) (256 bits wide) to supply up to eight 32-bit instructions to the eight functional units during every clock cycle. The VelociTI VLIW architecture features controls by which all eight units do not have to be supplied with instructions if they are not ready to execute. The first bit of every 32-bit instruction determines if the next instruction belongs to the same execute packet as the previous instruction, or whether it should be executed in the following clock as a part of the next execute packet. Fetch packets are always 256 bits wide; however, the execute packets can vary in size. The variable-length execute packets are a key memory-saving feature, distinguishing the 'C67x CPU from other VLIW architectures.

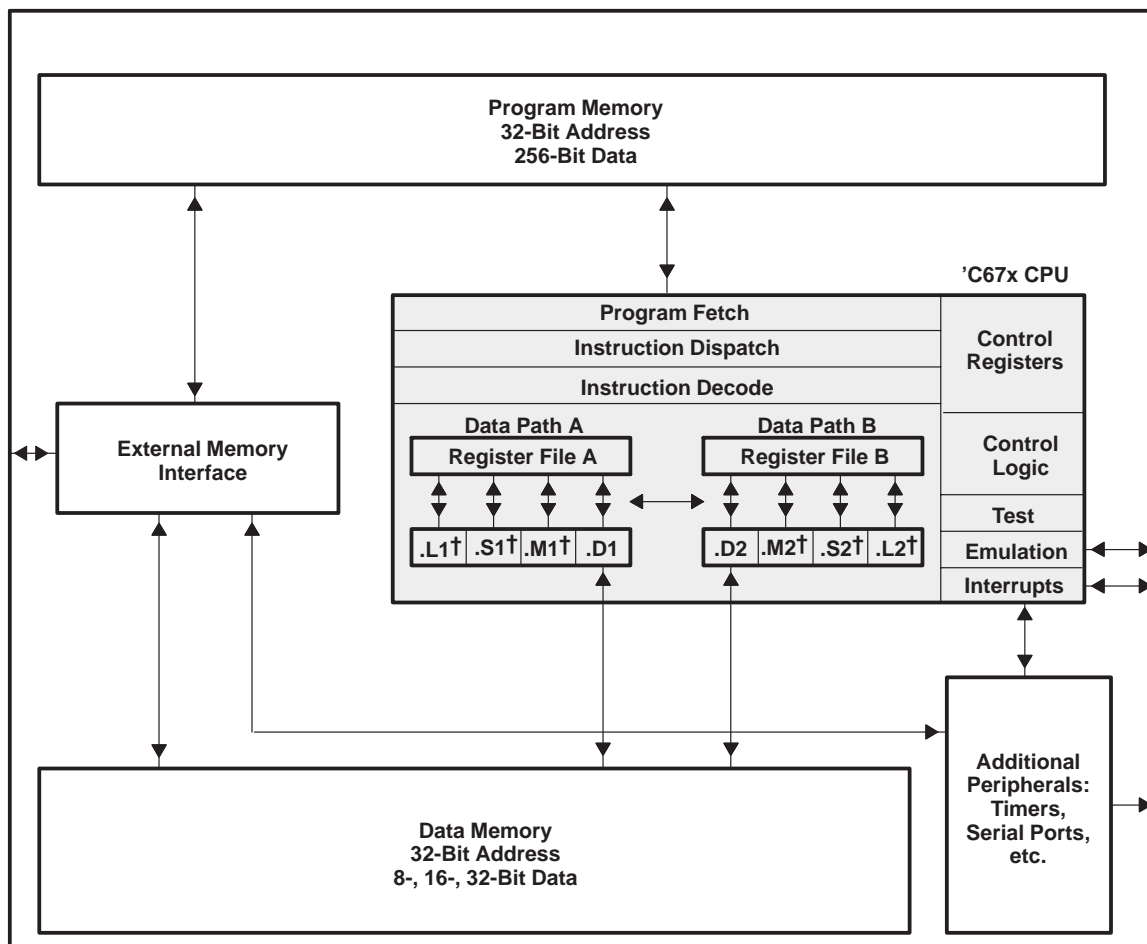
The CPU features two sets of functional units. Each set contains four units and a register file. One set contains functional units .L1, .S1, .M1, and .D1; the other set contains units .D2, .M2, .S2, and .L2. The two register files contain 16 32-bit registers each for the total of 32 general-purpose registers. The two sets of functional units, along with two register files, compose sides A and B of the CPU (see Figure 3 and Figure 4). The four functional units on each side of the CPU can freely share the 16 registers belonging to that side. Additionally, each side features a single data bus connected to all registers on the other side, by which the two sets of functional units can access data from the register files on opposite sides. While register access by functional units on the same side of the CPU as the register file can service all the units in a single clock cycle, register access using the register file across the CPU supports one read and one write per cycle.

The 'C67x CPU executes all 'C62x instructions. In addition to 'C62x fixed-point instructions, the six out of eight functional units (.L1, .M1, .D1, .D2, .M2, and .L2) also execute floating-point instructions. The remaining two functional units (.S1 and .S2) also execute the new LDDW instruction which loads 64 bits per CPU side for a total of 128 bits per cycle.

Another key feature of the 'C67x CPU is the load/store architecture, where all instructions operate on registers (as opposed to data in memory). Two sets of data-addressing units (.D1 and .D2) are responsible for all data transfers between the register files and the memory. The data address driven by the .D units allows data addresses generated from one register file to be used to load or store data to or from the other register file. The 'C67x CPU supports a variety of indirect-addressing modes using either linear- or circular-addressing modes with 5- or 15-bit offsets. All instructions are conditional, and most can access any one of the 32 registers. Some registers, however, are singled out to support specific addressing or to hold the condition for conditional instructions (if the condition is not automatically "true"). The two .M functional units are dedicated for multiplies. The two .S and .L functional units perform a general set of arithmetic, logical, and branch functions with results available every clock cycle.

The processing flow begins when a 256-bit-wide instruction fetch packet is fetched from a program memory. The 32-bit instructions destined for the individual functional units are "linked" together by "1" bits in the least significant bit (LSB) position of the instructions. The instructions that are "chained" together for simultaneous execution (up to eight in total) compose an execute packet. A "0" in the LSB of an instruction breaks the chain, effectively placing the instructions that follow it in the next execute packet. If an execute packet crosses the fetch-packet boundary (256 bits wide), the assembler places it in the next fetch packet, while the remainder of the current fetch packet is padded with NOP instructions. The number of execute packets within a fetch packet can vary from one to eight. Execute packets are dispatched to their respective functional units at the rate of one per clock cycle and the next 256-bit fetch packet is not fetched until all the execute packets from the current fetch packet have been dispatched. After decoding, the instructions simultaneously drive all active functional units for a maximum execution rate of eight instructions every clock cycle. While most results are stored in 32-bit registers, they can be subsequently moved to memory as bytes or half-words as well. All load and store instructions are byte-, half-word, or word-addressable.

CPU description (continued)



† These functional units execute floating-point instructions.

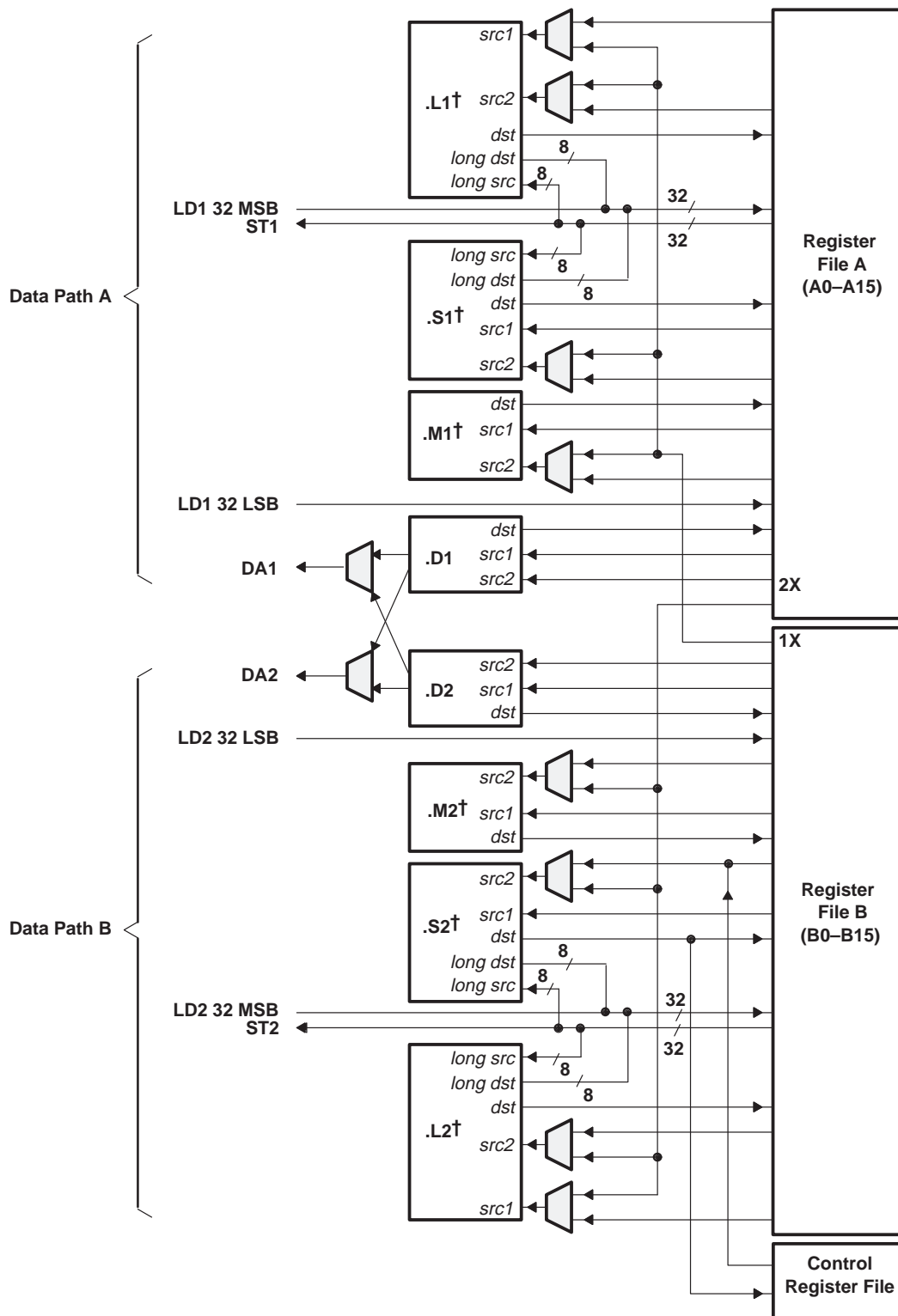
Figure 3. CPU Block Diagram

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CPU description (continued)



† These functional units execute floating-point instructions.

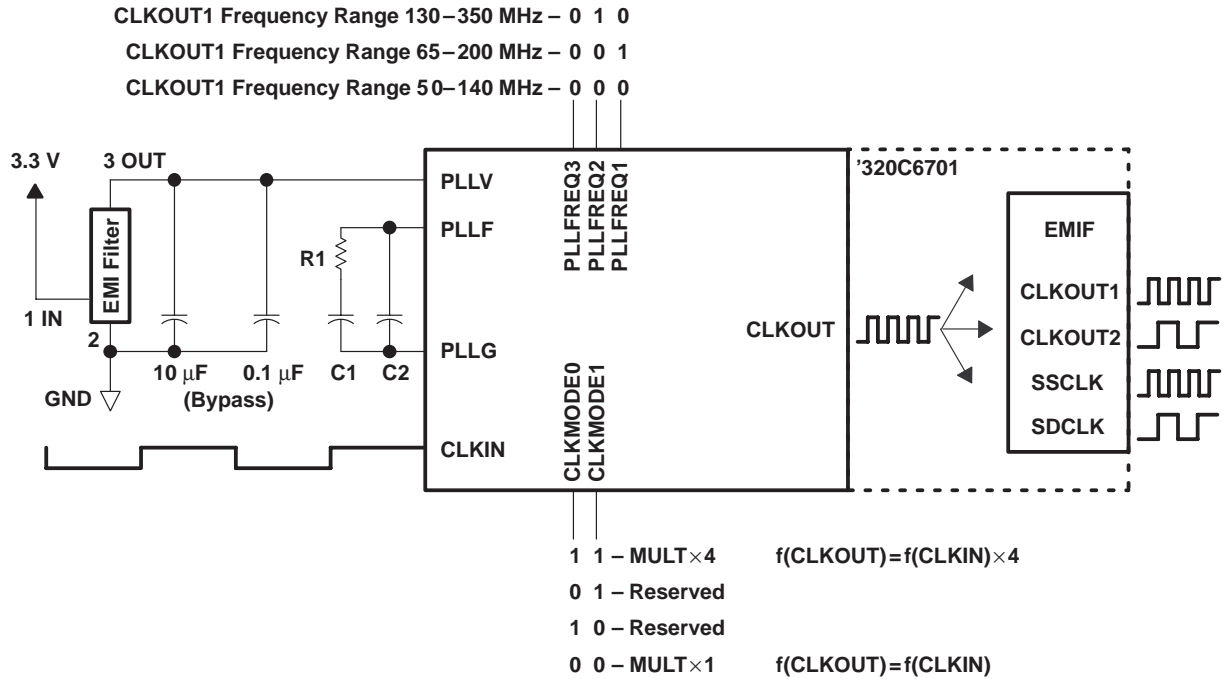
Figure 4. TMX320C67x CPU Data Paths

clock PLL

All of the 'C67x clocks are generated from a single source through the CLKIN pin. This source clock either drives the PLL, which generates the internal CPU clock, or bypasses the PLL to become the CPU clock.

To use the PLL to generate the CPU clock, the filter circuit shown in Figure 5 must be properly designed.

To configure the 'C67x PLL clock for proper operation, see Figure 5 and Table 1. To minimize the clock jitter, a single clean power supply should power both the 'C67x device and the external clock oscillator circuit. The minimum CLKIN rise and fall times should also be observed. See the section titled "input and output clocks" for input clock timing requirements.



- NOTES: A. For CLKMODE x4, values for C1, C2, and R1 depend on CLKIN and CLKOUT frequencies.
B. For CLKMODE x1, the PLL is bypassed and all six external PLL components can be removed. For this case, the PLLV terminal has to be connected to a clean 3.3-V supply and the PLLG and PLLF terminals should be tied together.
C. Due to overlap of frequency ranges when choosing the PLLFREQ, more than one frequency range can contain the CLKOUT1 frequency. Choose the lowest frequency range that includes the desired frequency. For example, for CLKOUT1 = 133 MHz, choose PLLFREQ value of 000b. For CLKOUT1 = 167 MHz, choose PLLFREQ value of 010b. PLLFREQ values other than 000b, 001b, and 010b are reserved.
D. EMI filter manufacturer TDK part number ACF451832-153-T

Figure 5. PLL Block Diagram

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clock PLL (continued)

Table 1. PLL Component Selection Table†

CYCLE TIME (ns)	CLKMODE	CLKIN (MHz)	CLKOUT1 (MHz)	R1 (Ω)	C1 (μF)	C2 (pF)	EMI FILTER PART NO.‡	TYPICAL LOCK TIME (μs)§
5	x4	50	200	16.9	0.15	2700	TDK #153	59
5.5	x4	45.5	181.8	13.7	0.18	3900	TDK #153	49
6	x4	41.6	166.7	17.4	0.15	3300	TDK #153	68
6.5	x4	38.5	153.8	16.2	0.18	3900	TDK #153	70
7	x4	35.7	142.9	15	0.22	3900	TDK #153	72
7.5	x4	33.3	133.3	16.2	0.22	3900	TDK #153	84
8	x4	31.3	125	14	0.27	4700	TDK #153	77
8.5	x4	29.4	117.7	11.8	0.33	6800	TDK #153	67
9	x4	27.7	111.1	11	0.39	6800	TDK #153	68
9.5	x4	26.3	105.3	10.5	0.39	8200	TDK #153	65
10	x4	25	100	10	0.47	8200	TDK #153	68

† For CLKMODE x1, the PLL is bypassed and all six external PLL components can be removed. For this case, the PLLV terminal has to be connected to a clean 3.3-V supply and the PLLG and PLLF terminals should be tied together.

‡ Full EMI filter part number : ACF 451832-153-T

§ Under some operating conditions, the maximum PLL lock time may vary as much as 150% from the specified typical value. For example, if the typical lock time is specified as 100 μs, the maximum value may be as long as 250 μs.

power-supply sequencing

The 1.8-V supply powers the core and the 3.3-V supply powers the I/O buffers. The core supply should be powered up first, or at the same time as the I/O buffers supply. This is to ensure that the I/O buffers have valid inputs from the core before the output buffers are powered up, thus preventing bus contention with other chips on the board.

development support

Texas Instruments (TI™) offers an extensive line of development tools for the 'C6x generation of DSPs, including tools to evaluate the performance of the processors, generate code, develop algorithm implementations, and fully integrate and debug software and hardware modules.

The following products support development of 'C6x-based applications:

Software-Development Tools:

Assembly optimizer
Assembler/Linker
Simulator
Optimizing ANSI C compiler
Application algorithms
C/Assembly debugger and code profiler

Hardware-Development Tools:

Extended development system (XDS™) emulator (supports 'C6x multiprocessor system debug)
EVM (Evaluation Module)

The *TMS320 DSP Development Support Reference Guide* (SPRU011) contains information about development-support products for all TMS320 family member devices, including documentation. See this document for further information on TMS320 documentation or any TMS320 support products from Texas Instruments. An additional document, the *TMS320 Third-Party Support Reference Guide* (SPRU052), contains information about TMS320-related products from other companies in the industry. To receive TMS320 literature, contact the Literature Response Center at 800/477-8924.

See Table 2 for a complete listing of development-support tools for the 'C6x. For information on pricing and availability, contact the nearest TI field sales office or authorized distributor.

Table 2. TMS320C6x Development-Support Tools

DEVELOPMENT TOOL	PLATFORM	PART NUMBER
Software		
C Compiler/Assembler/Linker/Assembly Optimizer	Win32™	TMDX3246855-07
C Compiler/Assembler/Linker/Assembly Optimizer	SPARC™ Solaris™	TMDX3246555-07
Simulator	Win32	TMDX3246851-07
Simulator	SPARC Solaris	TMDX3246551-07
XDS510™ Debugger/Emulation Software	Win32, Windows NT™	TMDX324016X-07
Hardware		
XDS510 Emulator†	PC	TMDX00510
XDS510WS™ Emulator‡	SCSI	TMDX00510WS
Software/Hardware		
EVM Evaluation Kit	PC/Win95/Windows NT	TMDX3260A6201
EVM Evaluation Kit (including TMDX3246855-07)	PC/Win95/Windows NT	TMDX326006201

† Includes XDS510 board and JTAG emulation cable. TMDX324016X-07 C-source Debugger/Emulation software is not included.

‡ Includes XDS510WS box, SCSI cable, power supply, and JTAG emulation cable.

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Win32 and Windows NT are trademarks of Microsoft Corporation.
SPARC is a trademark of SPARC International, Inc.
Solaris is a trademark of Sun Microsystems, Inc.



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device and development-support tool nomenclature

To designate the stages in the product-development cycle, TI assigns prefixes to the part numbers of all TMS320 devices and support tools. Each TMS320 member has one of three prefixes: TMX, TMP, or TMS. Texas Instruments recommends two of three possible prefix designators for support tools: TMDX and TMDS. These prefixes represent evolutionary stages of product development from engineering prototypes (TMX/TMDX) through fully qualified production devices/tools (TMS/TMDS).

Device development evolutionary flow:

- TMX** Experimental device that is not necessarily representative of the final device's electrical specifications
- TMP** Final silicon die that conforms to the device's electrical specifications but has not completed quality and reliability verification
- TMS** Fully qualified production device

Support tool development evolutionary flow:

- TMDX** Development-support product that has not yet completed Texas Instruments internal qualification testing.
- TMDS** Fully qualified development-support product

TMX and TMP devices and TMDX development-support tools are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

TMS devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (TMX or TMP) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the package type (for example, GJC) and the device speed range in megahertz (for example, -167 is 167 MHz). Figure 6 provides a legend for reading the complete device name for any TMS320 family member.

device and development-support tool nomenclature (continued)

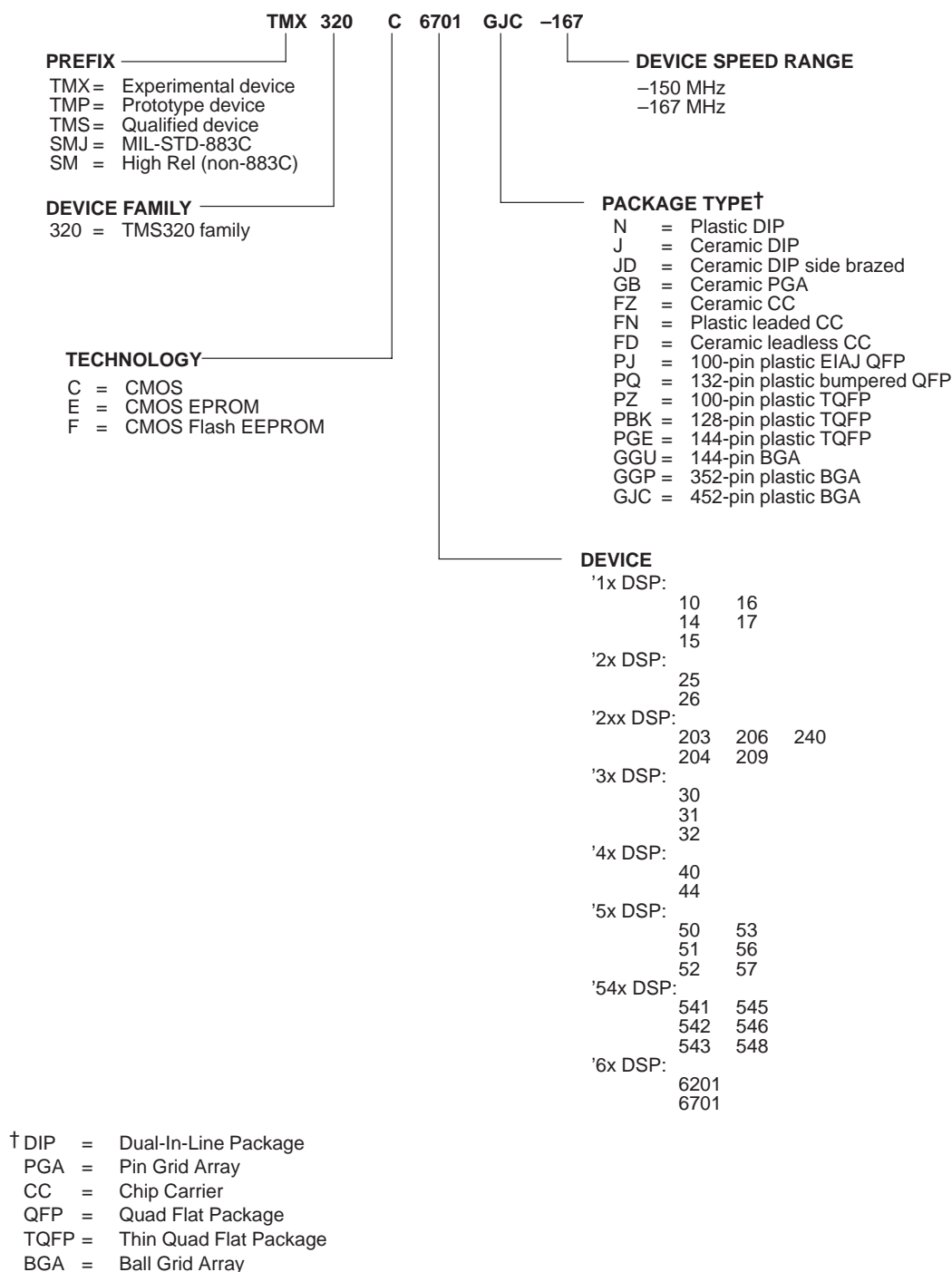


Figure 6. TMS320 Device Nomenclature (Including TMX320C6701)

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documentation support

Extensive documentation supports all TMS320 family generations of devices from product announcement through applications development. The types of documentation available include: data sheets, such as this document, with design specifications; complete user's reference guides for all devices; technical briefs; development-support tools; and hardware and software applications. The following is a brief, descriptive list of support documentation specific to the 'C6x devices:

The *TMS320C62x/C67x CPU and Instruction Set Reference Guide* (literature number SPRU189) describes the 'C62x/C67x CPU architecture, instruction set, pipeline, and associated interrupts.

The *TMS320C6201/C6701 Peripherals Reference Guide* (literature number SPRU190) describes functionally the peripherals available on 'C6x devices, such as the external memory interface (EMIF), host-port interface (HPI), multichannel buffered serial ports (McBSP), direct-memory-access (DMA) controller, clocking and phase-locked loop (PLL); and power-down modes. This guide also includes information on internal data and program memories.

The *TMS320C62x/C67x Programmer's Guide* (literature number SPRU198) describes ways to optimize C and assembly code for 'C6x devices and includes application program examples.

The *TMS320C6x Optimizing C Compiler User's Guide* (literature number SPRU187) describes the 'C6x C compiler and the assembly optimizer, explaining that the C compiler accepts ANSI standard C source code, and produces assembly language source code for the 'C6x generation devices, and that the assembly optimizer helps to optimize the programmer's assembly code.

The *TMS320C6x C Source Debugger User's Guide* (literature number SPRU188) describes how to invoke the 'C6x simulator and emulator versions of the C source debugger interface and discusses various aspects of the debugger, including: command entry, code execution, data management, breakpoints, profiling, and analysis.

The *TMS320C6x Peripheral Support Library Programmer's Reference* (literature number SPRU273) describes the contents of the 'C6x peripheral support library of functions and macros. It lists functions and macros both by header file and alphabetically, provides a complete description of each, and gives code examples to show how they are used.

The *TMS320C6x Evaluation Module Reference Guide* (literature number SPRU269) provides instructions for installing and operating the 'C6x evaluation module. It also includes support-software documentation, application programming interfaces, and technical reference material.

The *TMS320C62x/C67x Technical Brief* (literature number SPRU197) gives an introduction to the 'C62x/C67x devices, associated development tools, and third-party support.

A series of DSP textbooks is published by Prentice-Hall and John Wiley & Sons to support DSP research and education. The TMS320 newsletter, *Details on Signal Processing*, is published quarterly and distributed to update TMS320 customers on product information. The TMS320 DSP bulletin board service (BBS) provides access to information pertaining to the TMS320 family, including documentation, source code, and object code for many DSP algorithms and utilities. The BBS can be reached at 281/274-2323.

Information regarding TI DSP products is also available on the Worldwide Web at <http://www.ti.com> uniform resource locator (URL).

absolute maximum ratings over operating case temperature range (unless otherwise noted)†

Supply voltage range, CV_{DD} (see Note 1)	–0.3 V to 2.3 V
Supply voltage range, DV_{DD} (see Note 1)	–0.3 V to 4 V
Input voltage range	–0.3 V to 4 V
Output voltage range	–0.3 V to 4 V
Operating case temperature range, T_C	0°C to 90°C
Storage temperature range, T_{stg}	–55°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to V_{SS} .

recommended operating conditions

	MIN	NOM	MAX	UNIT
CV_{DD} Supply voltage	1.71	1.8	1.89	V
DV_{DD} Supply voltage	3.14	3.30	3.46	V
V_{SS} Supply ground	0	0	0	V
V_{IH} High-level input voltage	2.0			V
V_{IL} Low-level input voltage			0.8	V
I_{OH} High-level output current			–12	mA
I_{OL} Low-level output current			12	mA
T_C Case temperature	0		90	°C

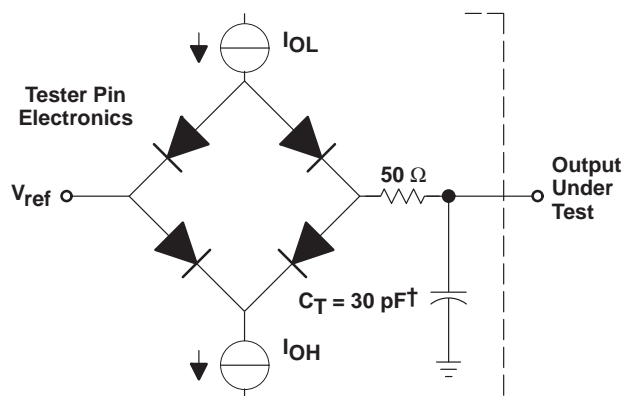
electrical characteristics over recommended ranges of supply voltage and operating case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH} High-level output voltage	$DV_{DD} = \text{MIN}$, $I_{OH} = \text{MAX}$	2.4			V
V_{OL} Low-level output voltage	$DV_{DD} = \text{MIN}$, $I_{OL} = \text{MAX}$			0.6	V
I_I Input current	$V_I = V_{SS}$ to DV_{DD}			±10	µA
I_{OZ} Off-state output current	$V_O = DV_{DD}$ or 0 V			±10	µA
I_{DD1V} Supply current	$CV_{DD} = \text{MAX}$, CLKOUT1 = 167 MHz		1.2		A
I_{DD3V} Supply current	$DV_{DD} = \text{MAX}$, CLKOUT1 = 167 MHz		200		mA
C_i Input capacitance				10	pF
C_o Output capacitance				10	pF

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PARAMETER MEASUREMENT INFORMATION



† Typical distributed load circuit capacitance.

signal-transition levels

All input and output timing parameters are referenced to 1.5 V for both “0” and “1” logic levels.

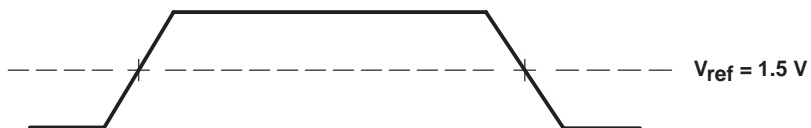


Figure 7. Input and Output Voltage Reference Levels for ac Timing Measurements

INPUT AND OUTPUT CLOCKS

timing requirements for CLKIN[†] (see Figure 8)

NO.			'C6701-150				'C6701-167				UNIT
			CLKMODE = x4		CLKMODE = x1		CLKMODE = x4		CLKMODE = x1		
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
1	t _c (CLKIN)	Cycle time, CLKIN	26.7		6.7		24		6		ns
2	t _w (CLKINH)	Pulse duration, CLKIN high	10.9		3		9.8		2.7		ns
3	t _w (CLKINL)	Pulse duration, CLKIN low	10.9		3		9.8		2.7		ns
4	t _t (CLKIN)	Transition time, CLKIN‡		5		0.6		5		0.6	ns

[†] The reference points for the rise and fall transitions are measured at 20% and 80%, respectively, of V_{IH} .

[‡] Values specified from characterization data and not tested.

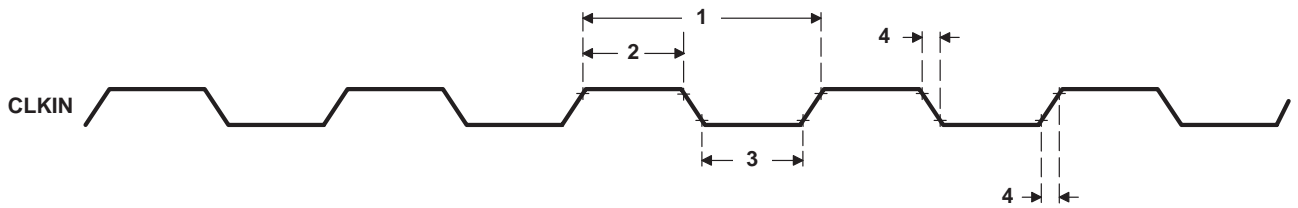


Figure 8. CLKIN Timings

switching characteristics for CLKOUT1^{§¶} (see Figure 9)

NO.	PARAMETER	'C6701-150 'C6701-167				UNIT
		CLKMODE = x4		CLKMODE = x1		
		MIN	MAX	MIN	MAX	
1	t _c (CKO1) Cycle time, CLKOUT1	P – 0.7	P + 0.7	P – 0.7	P + 0.7	ns
2	t _w (CKO1H) Pulse duration, CLKOUT1 high	(P/2) – 0.5	(P/2) + 0.5	PH – 0.5	PH + 0.5	ns
3	t _w (CKO1L) Pulse duration, CLKOUT1 low	(P/2) – 0.5	(P/2) + 0.5	PL – 0.5	PL + 0.5	ns
4	t _t (CKO1) Transition time, CLKOUT1‡		0.6		0.6	ns

[‡] Values specified from characterization data and not tested.

[§] $P = 1/\text{CPU clock frequency}$ in nanoseconds (ns).

[¶] PH is the high period of CLKOUT1 in ns and PL is the low period of CLKOUT1 in ns.

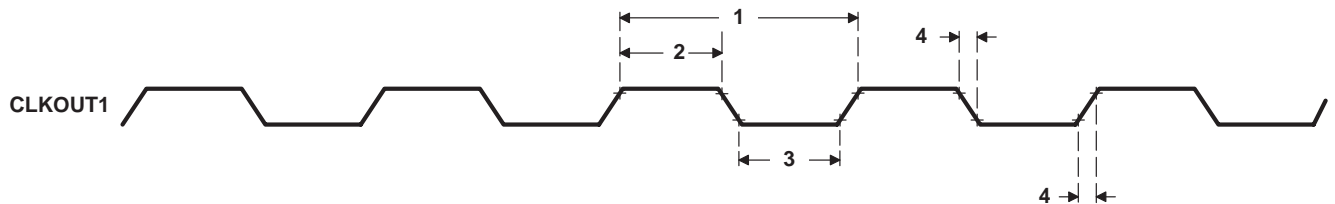


Figure 9. CLKOUT1 Timings

INPUT AND OUTPUT CLOCKS (CONTINUED)

switching characteristics for CLKOUT2[†] (see Figure 10)

NO.	PARAMETER	'C6701-150 'C6701-167		UNIT
		MIN	MAX	
1	$t_c(\text{CKO2})$ Cycle time, CLKOUT2	$2P - 0.7$	$2P + 0.7$	ns
2	$t_w(\text{CKO2H})$ Pulse duration, CLKOUT2 high	$P - 0.7$	$P + 0.7$	ns
3	$t_w(\text{CKO2L})$ Pulse duration, CLKOUT2 low	$P - 0.7$	$P + 0.7$	ns
4	$t_t(\text{CKO2})$ Transition time, CLKOUT2 [‡]		0.6	ns

[†] $P = 1/\text{CPU clock frequency}$ in ns.

[‡] Values specified from characterization data and not tested.

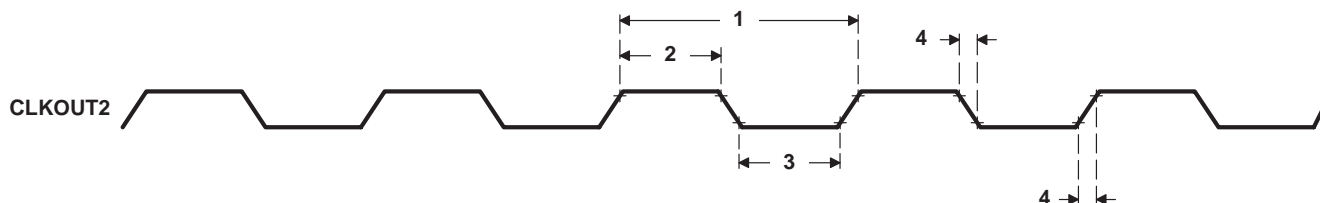


Figure 10. CLKOUT2 Timings

SDCLK, SSCLK timing parameters

SDCLK timing parameters are the same as CLKOUT2 parameters.

SSCLK timing parameters are the same as CLKOUT1 or CLKOUT2 parameters, depending on SSCLK configuration.

switching characteristics for the relation of SSCLK, SDCLK, and CLKOUT2 to CLKOUT1 (see Figure 11)

NO.	PARAMETER	'C6701-150 'C6701-167		UNIT
		MIN	MAX	
1	$t_d(\text{CKO1-SSCLK})$ Delay time, CLKOUT1 edge to SSCLK edge	-1.2	1.6	ns
2	$t_d(\text{CKO1-SSCLK1/2})$ Delay time, CLKOUT1 edge to SSCLK edge (1/2 clock rate)	-1.0	2.4	ns
3	$t_d(\text{CKO1-CKO2})$ Delay time, CLKOUT1 edge to CLKOUT2 edge	-1.0	2.4	ns
4	$t_d(\text{CKO1-SDCLK})$ Delay time, CLKOUT1 edge to SDCLK edge	-1.0	2.4	ns

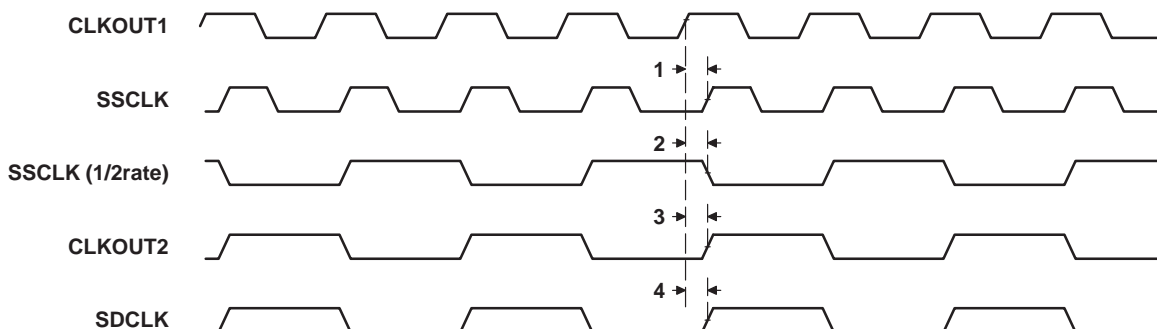


Figure 11. Relation of CLKOUT2, SDCLK, and SSCLK to CLKOUT1

ASYNCHRONOUS MEMORY TIMING

timing requirements for asynchronous memory cycles[†] (see Figure 12 and Figure 13)

NO.			'C6701-150 'C6701-167	UNIT
			MIN MAX	
6	$t_{su}(EDV-CKO1H)$	Setup time, read EDx valid before CLKOUT1 high	5.0	ns
7	$t_h(CKO1H-EDV)$	Hold time, read EDx valid after CLKOUT1 high	0	ns
10	$t_{su}(ARDY-CKO1H)$	Setup time, ARDY valid before CLKOUT1 high	5.0	ns
11	$t_h(CKO1H-ARDY)$	Hold time, ARDY valid after CLKOUT1 high	0	ns

[†] To ensure data setup time, simply program the strobe width wide enough. ARDY is internally synchronized. If ARDY does meet setup or hold time, it may be recognized in the current cycle or the next cycle. Thus, ARDY can be an asynchronous input.

switching characteristics for asynchronous memory cycles[‡] (see Figure 12 and Figure 13)

NO.	PARAMETER		'C6701-150 'C6701-167	UNIT
			MIN MAX	
1	$t_d(CKO1H-CEV)$	Delay time, CLKOUT1 high to \overline{CEx} valid	-1.0 5.0	ns
2	$t_d(CKO1H-BEV)$	Delay time, CLKOUT1 high to \overline{BEx} valid	-1.0 5.0	ns
3	$t_d(CKO1H-BEIV)$	Delay time, CLKOUT1 high to \overline{BEx} invalid [§]	-1.0 5.0	ns
4	$t_d(CKO1H-EAV)$	Delay time, CLKOUT1 high to EAx valid	-1.0 5.0	ns
5	$t_d(CKO1H-EAIV)$	Delay time, CLKOUT1 high to EAx invalid [§]	-1.0 5.0	ns
8	$t_d(CKO1H-AOEV)$	Delay time, CLKOUT1 high to \overline{AOE} valid	-1.0 5.0	ns
9	$t_d(CKO1H-AREV)$	Delay time, CLKOUT1 high to \overline{ARE} valid	-1.0 5.0	ns
12	$t_d(CKO1H-EDLZ)$	Delay time, CLKOUT1 high to EDx low impedance [§]	-1.0	ns
13	$t_d(CKO1H-EDV)$	Delay time, CLKOUT1 high to EDx valid	5.0	ns
14	$t_d(CKO1H-EDIV)$	Delay time, CLKOUT1 high to EDx invalid [§]	-1.0	ns
15	$t_d(CKO1H-EDHZ)$	Delay time, CLKOUT1 high to EDx high impedance [§]	6.5	ns
16	$t_d(CKO1H-AWEV)$	Delay time, CLKOUT1 high to \overline{AWE} valid	-1.0 5.0	ns

[‡] The minimum delay is also the minimum output hold after CLKOUT1 high.

[§] Values specified by design but not tested

ASYNCHRONOUS MEMORY TIMING (CONTINUED)

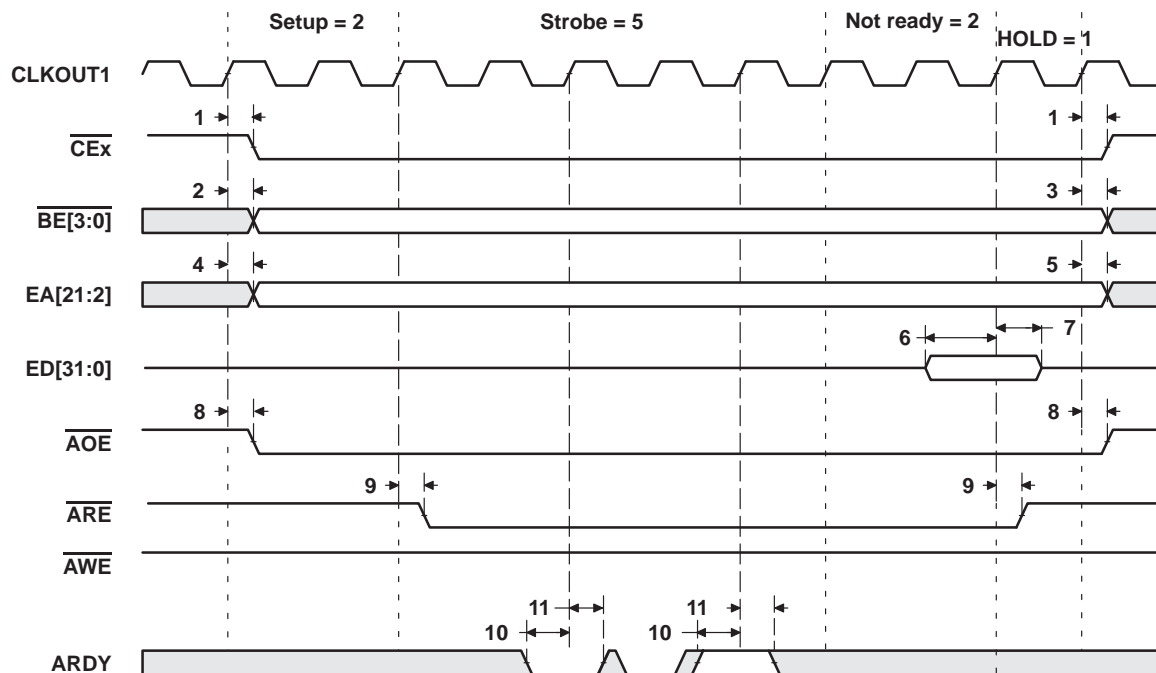


Figure 12. Asynchronous Memory Read Timing

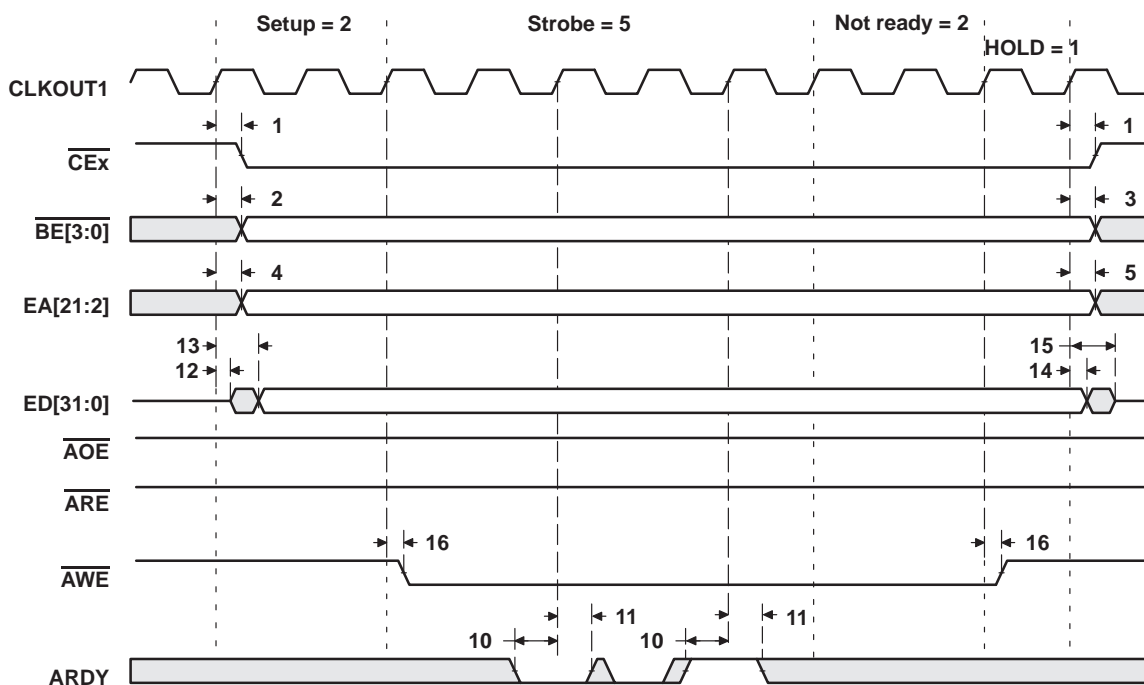


Figure 13. Asynchronous Memory Write Timing

SYNCHRONOUS-BURST MEMORY TIMING

timing requirements for synchronous-burst SRAM cycles (full-rate SSCLK)
(see Figure 14)

NO.		'C6701-150		'C6701-167		UNIT
		MIN	MAX	MIN	MAX	
7	$t_{su}(EDV-SSCLKH)$ Setup time, read EDx valid before SSCLK high	1.9		1.2		ns
8	$t_h(SSCLKH-EDV)$ Hold time, read EDx valid after SSCLK high	1.5		1.5		ns

switching characteristics for synchronous-burst SRAM cycles[†] (full-rate SSCLK)
(see Figure 14 and Figure 15)

NO.	PARAMETER	'C6701-150		'C6701-167		UNIT
		MIN	MAX	MIN	MAX	
1	$t_{su}(CEV-SSCLKH)$ Setup time, $\overline{CE}x$ valid before SSCLK high	0.5P – 1.5		0.5P – 1.2		ns
2	$t_{oh}(SSCLKH-CEV)$ Output hold time, $\overline{CE}x$ valid after SSCLK high	0.5P – 2.5		0.5P – 2.2		ns
3	$t_{su}(BEV-SSCLKH)$ Setup time, $\overline{BE}x$ valid before SSCLK high	0.5P – 1.5		0.5P – 1.2		ns
4	$t_{oh}(SSCLKH-BEIV)$ Output hold time, $\overline{BE}x$ invalid after SSCLK high [‡]	0.5P – 2.5		0.5P – 2.2		ns
5	$t_{su}(EAV-SSCLKH)$ Setup time, EAx valid before SSCLK high	0.5P – 1.5		0.5P – 1.2		ns
6	$t_{oh}(SSCLKH-EAIV)$ Output hold time, EAx invalid after SSCLK high [‡]	0.5P – 2.5		0.5P – 2.2		ns
9	$t_{su}(ADSV-SSCLKH)$ Setup time, \overline{SSADS} valid before SSCLK high	0.5P – 1.5		0.5P – 1.2		ns
10	$t_{oh}(SSCLKH-ADSV)$ Output hold time, \overline{SSADS} valid after SSCLK high	0.5P – 2.5		0.5P – 2.2		ns
11	$t_{su}(OEV-SSCLKH)$ Setup time, \overline{SSOE} valid before SSCLK high	0.5P – 1.5		0.5P – 1.2		ns
12	$t_{oh}(SSCLKH-OEV)$ Output hold time, \overline{SSOE} valid after SSCLK high	0.5P – 2.5		0.5P – 2.2		ns
13	$t_{su}(EDLZ-SSCLKH)$ Setup time, EDx low impedance before SSCLK high ^{‡§}	0.5P – 1.5		0.5P – 1.2		ns
14	$t_{su}(EDV-SSCLKH)$ Setup time, EDx valid before SSCLK high	0.5P – 1.5		0.5P – 1.2		ns
15	$t_{oh}(SSCLKH-EDIV)$ Output hold time, EDx invalid after SSCLK high [‡]	0.5P – 2.5		0.5P – 2.2		ns
16	$t_{dis}(SSCLKH-EDHZ)$ Disable time, EDx high impedance from SSCLK high [‡]		3		3	ns
17	$t_{su}(WEV-SSCLKH)$ Setup time, \overline{SSWE} valid before SSCLK high	0.5P – 1.5		0.5P – 1.2		ns
18	$t_{oh}(SSCLKH-WEV)$ Output hold time, \overline{SSWE} valid after SSCLK high	0.5P – 2.5		0.5P – 2.2		ns

[†] The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter or SSCLK duty cycle.
P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

[‡] Values specified by design but not tested

[§] This parameter applies to the first write in a series of one or more consecutive adjacent writes. The write data is generated two CLKOUT1 cycles early to accommodate the ED enable time.

ADVANCE INFORMATION

SYNCHRONOUS-BURST MEMORY TIMING (CONTINUED)

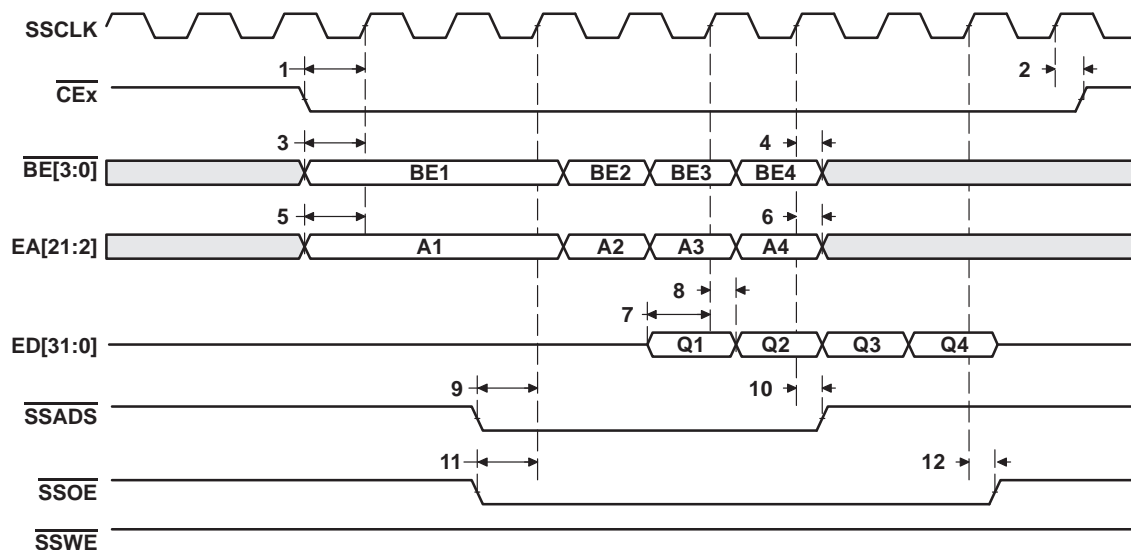


Figure 14. SBSRAM Read Timing (Full-Rate SSCLK)

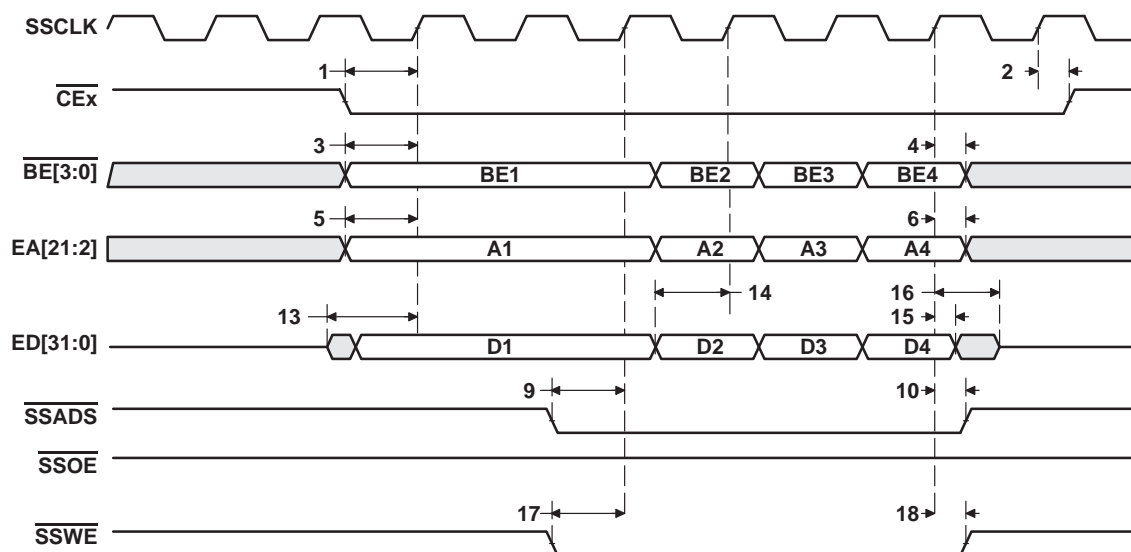


Figure 15. SBSRAM Write Timing (Full-Rate SSCLK)

SYNCHRONOUS-BURST MEMORY TIMING (CONTINUED)

timing requirements for synchronous-burst SRAM cycles (half-rate SSCLK) (see Figure 16)

NO.		'C6701-150		'C6701-167		UNIT
		MIN	MAX	MIN	MAX	
7	$t_{su}(EDV-SSCLKH)$ Setup time, read EDx valid before SSCLK high	3.8		3.5		ns
8	$t_h(SSCLKH-EDV)$ Hold time, read EDx valid after SSCLK high	2		1.5		ns

switching characteristics for synchronous-burst SRAM cycles[†] (half-rate SSCLK)
(see Figure 16 and Figure 17)

NO.	PARAMETER	'C6701-150		'C6701-167		UNIT
		MIN	MAX	MIN	MAX	
1	$t_{su}(CEV-SSCLKH)$ Setup time, $\overline{CE}x$ valid before SSCLK high	1.5P – 5.5		1.5P – 4.5		ns
2	$t_{oh}(SSCLKH-CEV)$ Output hold time, $\overline{CE}x$ valid after SSCLK high	0.5P – 2.3		0.5P – 2		ns
3	$t_{su}(BEV-SSCLKH)$ Setup time, $\overline{BE}x$ valid before SSCLK high	1.5P – 5.5		1.5P – 4.5		ns
4	$t_{oh}(SSCLKH-BEIV)$ Output hold time, $\overline{BE}x$ invalid after SSCLK high [‡]	0.5P – 2.3		0.5P – 2		ns
5	$t_{su}(EAV-SSCLKH)$ Setup time, EAx valid before SSCLK high	1.5P – 5.5		1.5P – 4.5		ns
6	$t_{oh}(SSCLKH-EAIV)$ Output hold time, EAx invalid after SSCLK high [‡]	0.5P – 2.3		0.5P – 2		ns
9	$t_{su}(ADSV-SSCLKH)$ Setup time, \overline{SSADS} valid before SSCLK high	1.5P – 5.5		1.5P – 4.5		ns
10	$t_{oh}(SSCLKH-ADSV)$ Output hold time, \overline{SSADS} valid after SSCLK high	0.5P – 2.3		0.5P – 2		ns
11	$t_{su}(OEV-SSCLKH)$ Setup time, \overline{SSOE} valid before SSCLK high	1.5P – 5.5		1.5P – 4.5		ns
12	$t_{oh}(SSCLKH-OEV)$ Output hold time, \overline{SSOE} valid after SSCLK high	0.5P – 2.3		0.5P – 2		ns
13	$t_{su}(EDLZ-SSCLKH)$ Setup time, EDx low impedance before SSCLK high ^{‡§}	1.5P – 5.5		1.5P – 4.5		ns
14	$t_{su}(EDV-SSCLKH)$ Setup time, EDx valid before SSCLK high	1.5P – 5.5		1.5P – 4.5		ns
15	$t_{oh}(SSCLKH-EDIV)$ Output hold time, EDx invalid after SSCLK high [‡]	0.5P – 2.3		0.5P – 2		ns
16	$t_{dis}(SSCLKH-EDHZ)$ Disable time, EDx high impedance from SSCLK high [‡]		3		3	ns
17	$t_{su}(WEV-SSCLKH)$ Setup time, \overline{SSWE} valid before SSCLK high	1.5P – 5.5		1.5P – 4.5		ns
18	$t_{oh}(SSCLKH-WEV)$ Output hold time, \overline{SSWE} valid after SSCLK high	0.5P – 2.3		0.5P – 2		ns

[†] The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter or SSCLK duty cycle.
P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

[‡] Values specified by design but not tested

[§] This parameter applies to the first write in a series of one or more consecutive adjacent writes. The write data is generated two CLKOUT1 cycles early to accommodate the ED enable time.

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SYNCHRONOUS-BURST MEMORY TIMING (CONTINUED)

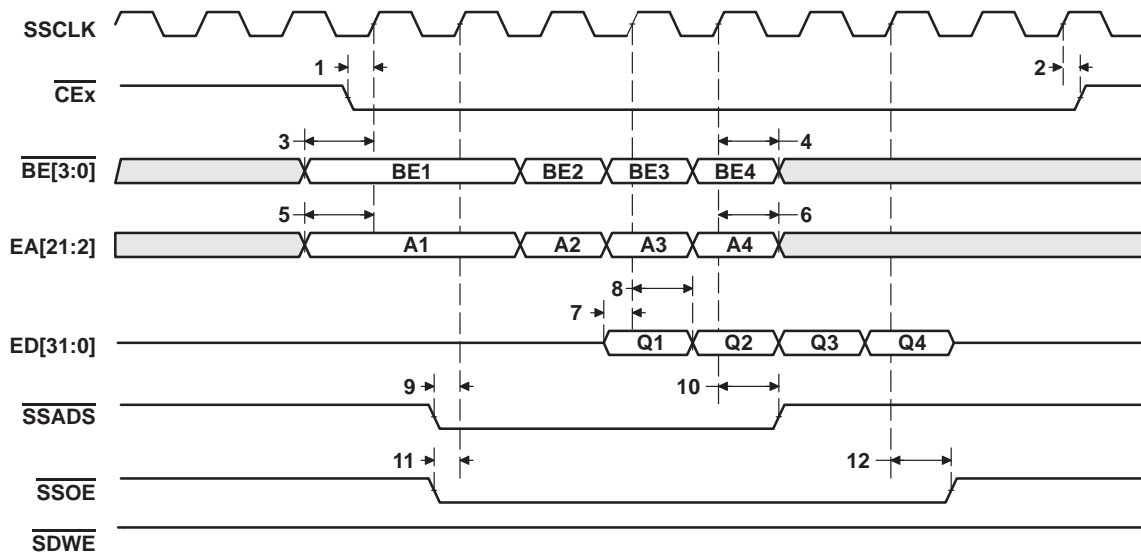


Figure 16. SBSRAM Read Timing (1/2 Rate SSCLK)

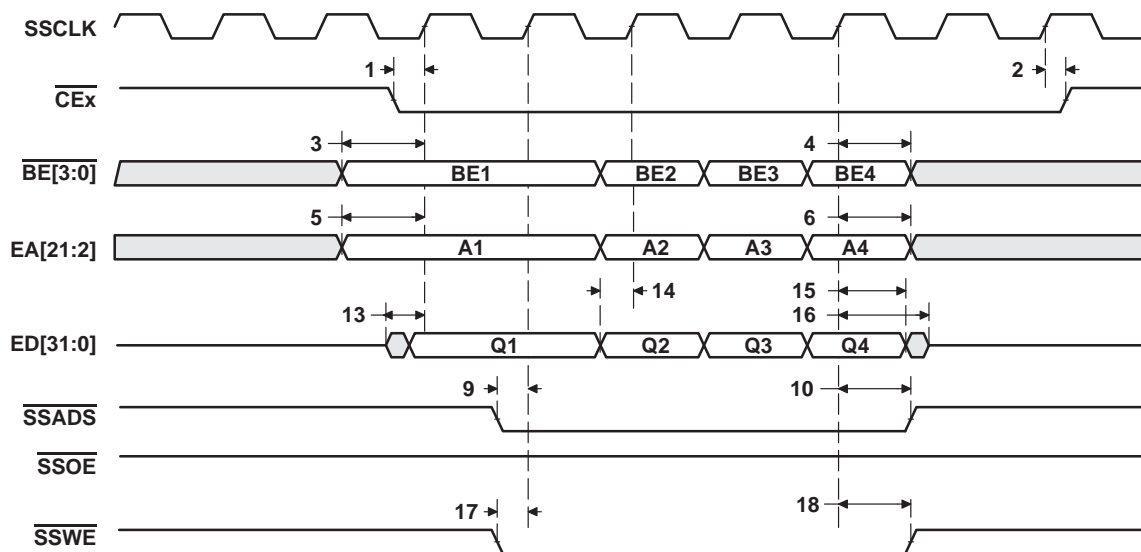


Figure 17. SBSRAM Write Timing (1/2 Rate SSCLK)

SYNCHRONOUS DRAM TIMING

timing requirements for synchronous DRAM cycles (see Figure 18)

NO.		'C6701-150		'C6701-167		UNIT
		MIN	MAX	MIN	MAX	
7	$t_{su}(EDV-SDCLKH)$ Setup time, read EDx valid before SDCLK high	1.8		0.5		ns
8	$t_h(SDCLKH-EDV)$ Hold time, read EDx valid after SDCLK high	3		3		ns

switching characteristics for synchronous DRAM cycles^{†‡} (see Figure 18–Figure 23)

NO.	PARAMETER		'C6701-150		'C6701-167		UNIT
			MIN	MAX	MIN	MAX	
1	$t_{su}(CEV-SDCLKH)$ Setup time, $\overline{CE}x$ valid before SDCLK high		1.5P – 5		1.5P – 4		ns
2	$t_{oh}(SDCLKH-CEV)$ Output hold time, $\overline{CE}x$ valid after SDCLK high		0.5P – 1.9		0.5P – 1.5		ns
3	$t_{su}(BEV-SDCLKH)$ Setup time, $\overline{BE}x$ valid before SDCLK high		1.5P – 5		1.5P – 4		ns
4	$t_{oh}(SDCLKH-BEIV)$ Output hold time, $\overline{BE}x$ invalid after SDCLK high [§]		0.5P – 1.9		0.5P – 1.5		ns
5	$t_{su}(EAV-SDCLKH)$ Setup time, EAx valid before SDCLK high		1.5P – 5		1.5P – 4		ns
6	$t_{oh}(SDCLKH-EAIV)$ Output hold time, EAx invalid after SDCLK high [§]		0.5P – 1.9		0.5P – 1.5		ns
9	$t_{su}(SDCAS-SDCLKH)$ Setup time, \overline{SDCAS} valid before SDCLK high		1.5P – 5		1.5P – 4		ns
10	$t_{oh}(SDCLKH-SDCAS)$ Output hold time, \overline{SDCAS} valid after SDCLK high		0.5P – 1.9		0.5P – 1.5		ns
11	$t_{su}(EDLZ-SDCLKH)$ Setup time, EDx low impedance before SDCLK high [§]		1.5P – 5		1.5P – 4		ns
12	$t_{su}(EDV-SDCLKH)$ Setup time, EDx valid before SDCLK high		1.5P – 5		1.5P – 4		ns
13	$t_{oh}(SDCLKH-EDIV)$ Output hold time, EDx invalid after SDCLK high [§]		0.5P – 1.9		0.5P – 1.5		ns
14	$t_{dis}(SDCLKH-EDHZ)$ Disable time, EDx high impedance from SDCLK high [§]			3		3	ns
15	$t_{su}(SDWE-SDCLKH)$ Setup time, \overline{SDWE} valid before SDCLK high		1.5P – 5		1.5P – 4		ns
16	$t_{oh}(SDCLKH-SDWE)$ Output hold time, \overline{SDWE} valid after SDCLK high		0.5P – 1.9		0.5P – 1.5		ns
17	$t_{su}(SDA10V-SDCLKH)$ Setup time, SDA10 valid before SDCLK high		1.5P – 5		1.5P – 4		ns
18	$t_{oh}(SDCLKH-SDA10IV)$ Output hold time, SDA10 invalid after SDCLK high [§]		0.5P – 1.9		0.5P – 1.5		ns
19	$t_{su}(SDRAS-SDCLKH)$ Setup time, \overline{SDRAS} valid before SDCLK high		1.5P – 5		1.5P – 4		ns
20	$t_{oh}(SDCLKH-SDRAS)$ Output hold time, \overline{SDRAS} valid after SDCLK high		0.5P – 1.9		0.5P – 1.5		ns

[†] The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter or SSCLK duty cycle.

P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

[‡] The minimum delay also represents the minimum output hold time after SDCLK high.

[§] Values specified by design but not tested

ADVANCE INFORMATION

SYNCHRONOUS DRAM TIMING (CONTINUED)

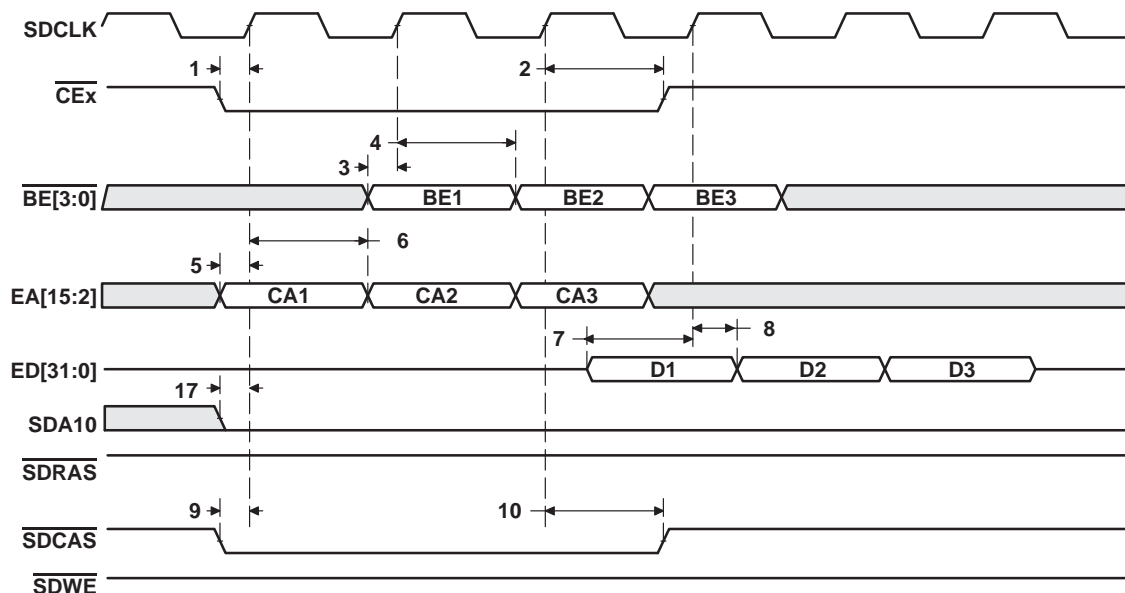


Figure 18. Three SDRAM Read Commands

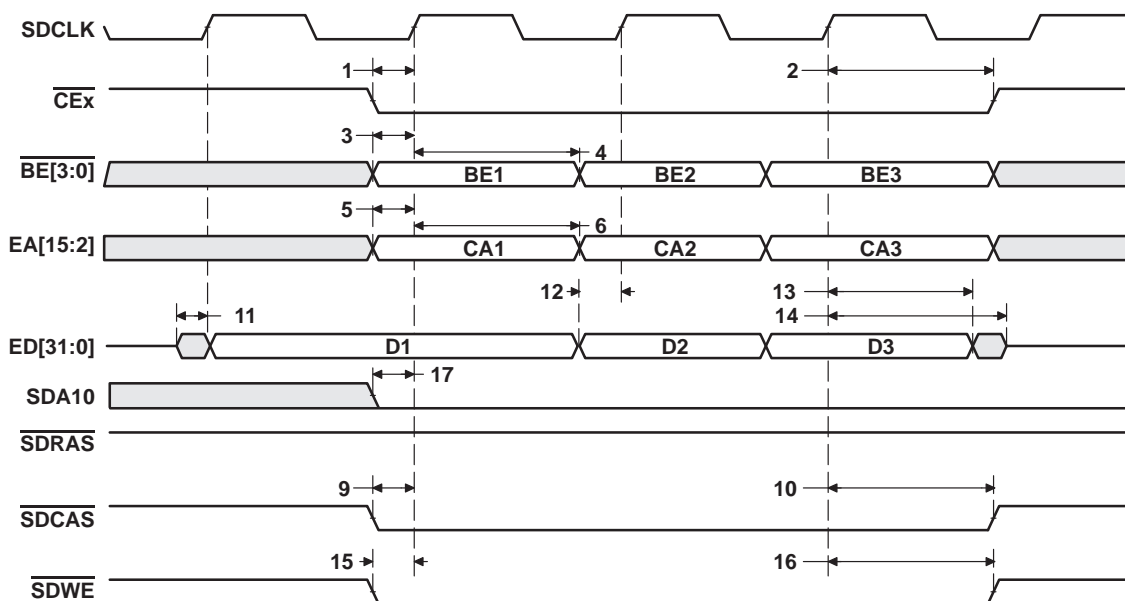


Figure 19. Three SDRAM WRT Commands

SYNCHRONOUS DRAM TIMING (CONTINUED)

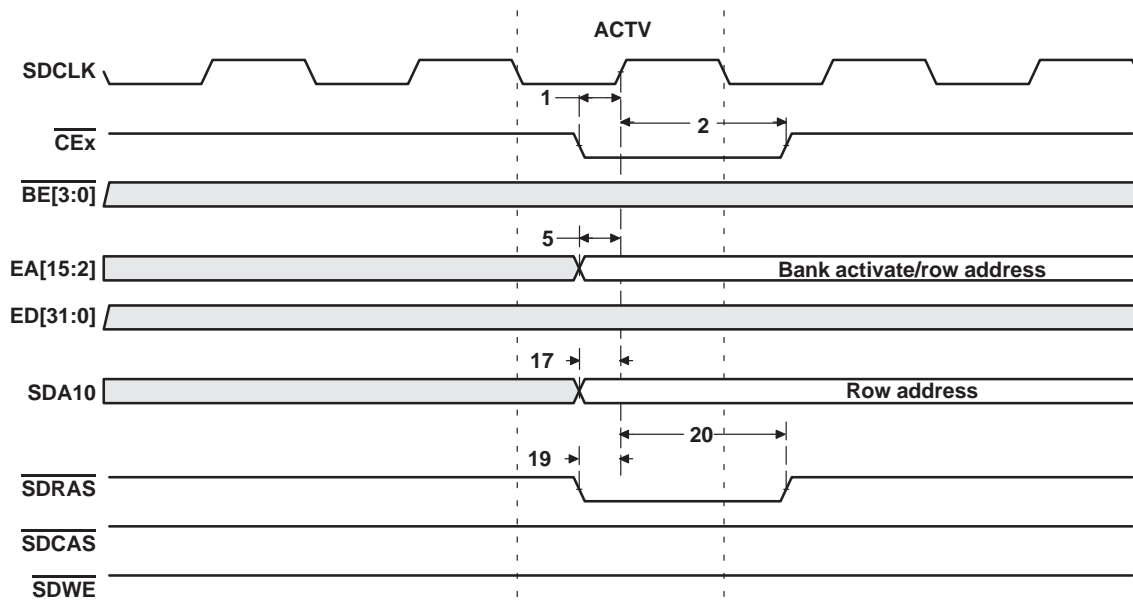


Figure 20. SDRAM ACTV Command

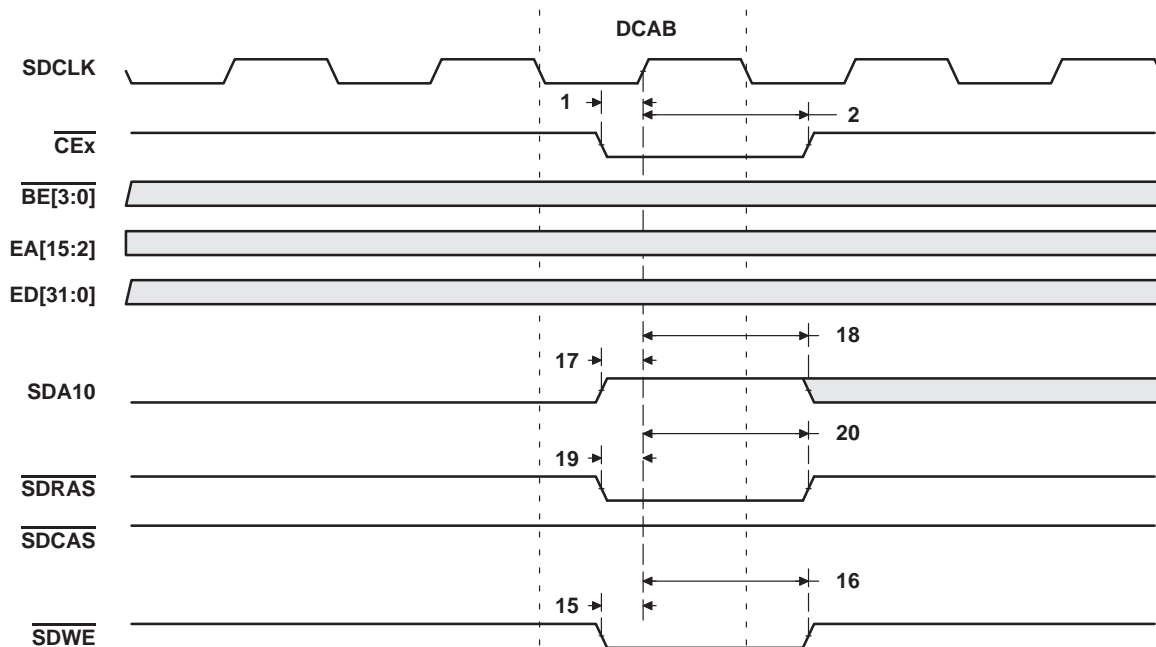


Figure 21. SDRAM DCAB Command

SYNCHRONOUS DRAM TIMING (CONTINUED)

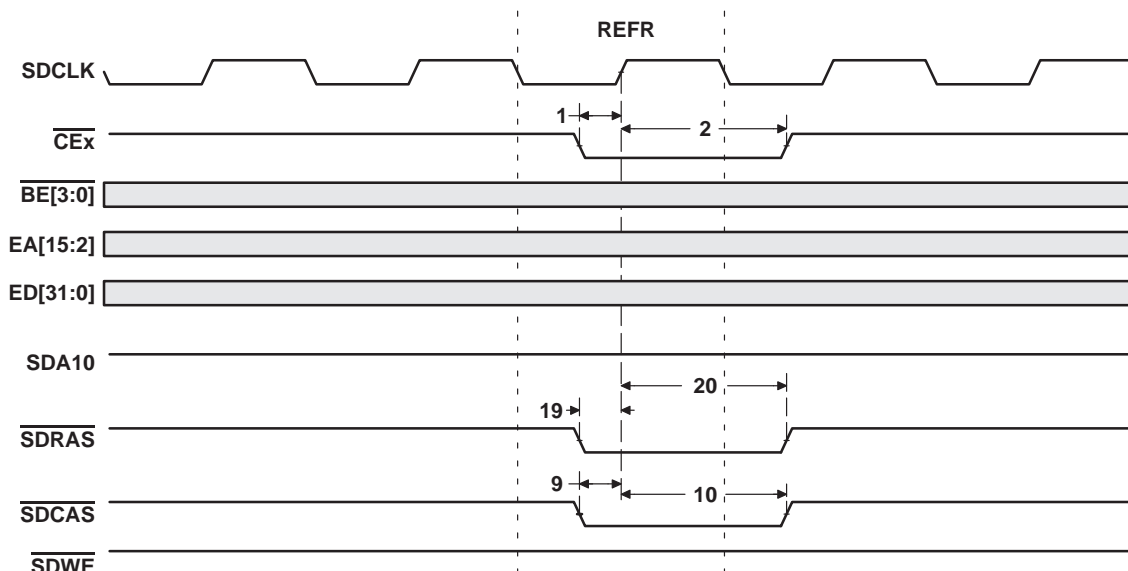


Figure 22. SDRAM REFR Command

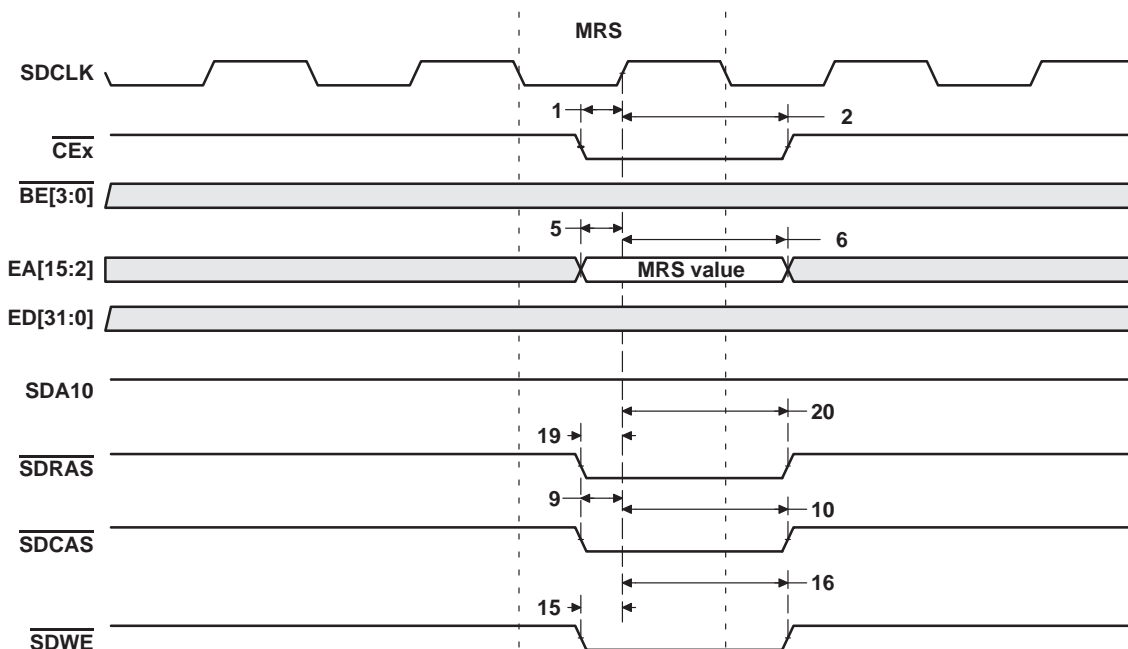


Figure 23. SDRAM MRS Command

HOLD/HOLDA TIMING

timing requirements for the hold/hold acknowledge cycles[†] (see Figure 24)

NO.		'C6701-150 'C6701-167	UNIT
		MIN MAX	
1	$t_{su}(\text{HOLDH-CKO1H})$ Setup time, $\overline{\text{HOLD}}$ high before CLKOUT1 high	5	ns
2	$t_h(\text{CKO1H-HOLDL})$ Hold time, $\overline{\text{HOLD}}$ low after CLKOUT1 high	0	ns

[†] $\overline{\text{HOLD}}$ is synchronized internally. Therefore, if setup and hold times are not met, it will either be recognized in the current cycle or in the next cycle. Thus, $\overline{\text{HOLD}}$ can be an asynchronous input.

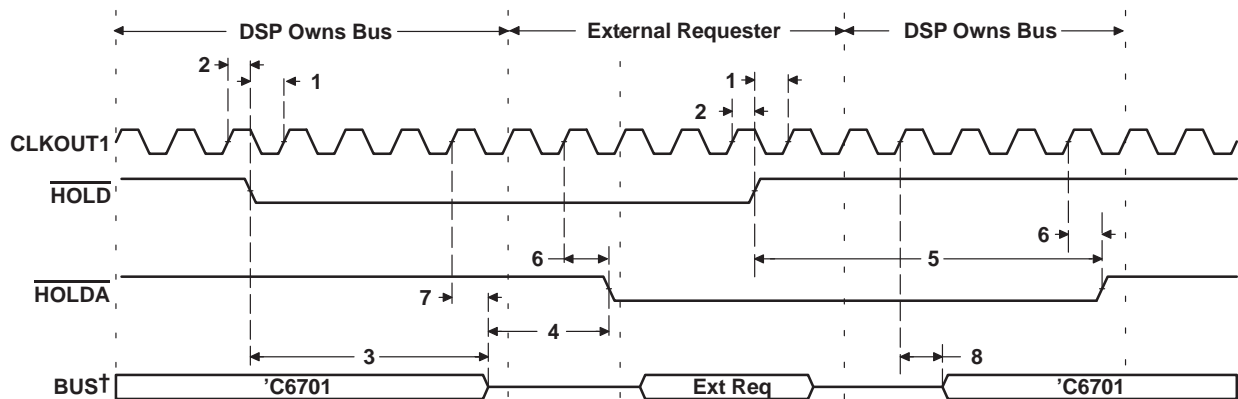
switching characteristics for the hold/hold acknowledge cycles (see Figure 24)

NO.	PARAMETER	'C6701-150 'C6701-167	UNIT
		MIN MAX	
3	$t_R(\text{HOLDL-EMHZ})$ Response time, $\overline{\text{HOLD}}$ low to EMIF high impedance [‡]	4	§ CLKOUT1 cycles
4	$t_d(\text{EMHZ-HOLDAL})$ Delay time, EMIF high impedance to $\overline{\text{HOLDA}}$ low [‡]	2	CLKOUT1 cycles
5	$t_R(\text{HOLDH-HOLDAH})$ Response time, $\overline{\text{HOLD}}$ high to $\overline{\text{HOLDA}}$ high [‡]	6	CLKOUT1 cycles
6	$t_d(\text{CKO1H-HOLDAL})$ Delay time, CLKOUT1 high to $\overline{\text{HOLDA}}$ valid	-1 5	ns
7	$t_d(\text{CKO1H-BHZ})$ Delay time, CLKOUT1 high to BUS high impedance ^{†¶}	-1 5	ns
8	$t_d(\text{CKO1H-BLZ})$ Delay time, CLKOUT1 high to BUS low impedance ^{†¶}	-1 5	ns

[‡] Values specified by design but not tested

§ All pending EMIF transactions are allowed to complete before $\overline{\text{HOLDA}}$ is asserted. The worst cases for this is an asynchronous read or write with external ARDY used or a minimum of eight consecutive SDRAM reads or writes when RBTR8 = 1. If no bus transactions are occurring, then the minimum delay time can be achieved. Also, bus hold can be indefinitely delayed by setting the NOHOLD = 1.

[¶] BUS consists of $\overline{\text{CE}}[3:0]$, $\overline{\text{BE}}[3:0]$, $\overline{\text{ED}}[31:0]$, $\overline{\text{EA}}[21:2]$, $\overline{\text{ARE}}$, $\overline{\text{AOE}}$, $\overline{\text{AWE}}$, $\overline{\text{SSADS}}$, $\overline{\text{SSOE}}$, $\overline{\text{SSWE}}$, $\overline{\text{SDA10}}$, $\overline{\text{SDRAS}}$, $\overline{\text{SDCAS}}$, and $\overline{\text{SDWE}}$.



[†] BUS consists of $\overline{\text{CE}}[3:0]$, $\overline{\text{BE}}[3:0]$, $\overline{\text{ED}}[31:0]$, $\overline{\text{EA}}[21:2]$, $\overline{\text{ARE}}$, $\overline{\text{AOE}}$, $\overline{\text{AWE}}$, $\overline{\text{SSADS}}$, $\overline{\text{SSOE}}$, $\overline{\text{SSWE}}$, $\overline{\text{SDA10}}$, $\overline{\text{SDRAS}}$, $\overline{\text{SDCAS}}$, and $\overline{\text{SDWE}}$.

Figure 24. $\overline{\text{HOLD}}/\overline{\text{HOLDA}}$ Timing

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RESET TIMING

timing requirements for reset[†] (see Figure 25)

NO.			'C6701-150 'C6701-167	UNIT
			MIN MAX	
1	$t_{w}(\text{RESET})$	Width of the $\overline{\text{RESET}}$ pulse (PLL stable)	10 [‡]	CLKOUT1 cycles
		Width of the $\overline{\text{RESET}}$ pulse (PLL needs to sync up) [§]	250 [‡]	μs

[†] As long as the RESET pulse satisfies $t_{w}(\text{RESET})$ or $t_r(\text{RESET})$ (as applicable), it need not satisfy the setup and hold times. Thus, RESET can be an asynchronous input.

[‡] Values specified from characterization data and not tested

[§] The RESET signal is not connected internally to the clock PLL circuit. The PLL, however, may need up to 250 μs to stabilize following device power up or after PLL configuration has been changed. During that time, RESET must be asserted to ensure proper device operation. See the clock PLL section for PLL lock times.

switching characteristics during reset[¶] (see Figure 25)

NO.	PARAMETER		'C6701-150 'C6701-167	UNIT
			MIN MAX	
2	$t_R(\text{RESET})$	Response time to change of value in $\overline{\text{RESET}}$ signal	2	CLKOUT1 cycles
3	$t_d(\text{CKO1H-CKO2IV})$	Delay time, CLKOUT1 high to CLKOUT2 invalid [#]	-1 10	ns
4	$t_d(\text{CKO1H-CKO2V})$	Delay time, CLKOUT1 high to CLKOUT2 valid	-1 10	ns
5	$t_d(\text{CKO1H-SDCLKIV})$	Delay time, CLKOUT1 high to SDCLK invalid [#]	-1 10	ns
6	$t_d(\text{CKO1H-SDCLKV})$	Delay time, CLKOUT1 high to SDCLK valid	-1 10	ns
7	$t_d(\text{CKO1H-SSCKIV})$	Delay time, CLKOUT1 high to SSCLK invalid [#]	-1 10	ns
8	$t_d(\text{CKO1H-SSCKV})$	Delay time, CLKOUT1 high to SSCLK valid	-1 10	ns
9	$t_d(\text{CKO1H-LOWIV})$	Delay time, CLKOUT1 high to low group invalid [#]	-1 10	ns
10	$t_d(\text{CKO1H-LOWV})$	Delay time, CLKOUT1 high to low group valid	-1 10	ns
11	$t_d(\text{CKO1H-HIGHIV})$	Delay time, CLKOUT1 high to high group invalid [#]	-1 10	ns
12	$t_d(\text{CKO1H-HIGHV})$	Delay time, CLKOUT1 high to high group valid	-1 10	ns
13	$t_d(\text{CKO1H-ZHZ})$	Delay time, CLKOUT1 high to Z group high impedance [#]	-1 10	ns
14	$t_d(\text{CKO1H-ZV})$	Delay time, CLKOUT1 high to Z group valid	-1 10	ns

[¶] Low group consists of: $\overline{\text{IACK}}$, $\overline{\text{INUM}}[3:0]$, $\overline{\text{DMAC}}[3:0]$, $\overline{\text{PD}}$, $\overline{\text{TOUT0}}$, and $\overline{\text{TOUT1}}$.

High group consists of: $\overline{\text{HRDY}}$ and $\overline{\text{HINT}}$.

Z group consists of: $\overline{\text{EA}}[21:2]$, $\overline{\text{ED}}[31:0]$, $\overline{\text{CE}}[3:0]$, $\overline{\text{BE}}[3:0]$, $\overline{\text{ARE}}$, $\overline{\text{AWE}}$, $\overline{\text{AOE}}$, $\overline{\text{SSADS}}$, $\overline{\text{SSOE}}$, $\overline{\text{SSWE}}$, $\overline{\text{SSCLK}}$, $\overline{\text{SDA10}}$, $\overline{\text{SDRAS}}$, $\overline{\text{SDCAS}}$, $\overline{\text{SDWE}}$, $\overline{\text{SDCLK}}$, $\overline{\text{HD}}[15:0]$, $\overline{\text{CLKX0}}$, $\overline{\text{CLKX1}}$, $\overline{\text{FSX0}}$, $\overline{\text{FSX1}}$, $\overline{\text{DX0}}$, $\overline{\text{DX1}}$, $\overline{\text{CLKR0}}$, $\overline{\text{CLKR1}}$, $\overline{\text{FSR0}}$, and $\overline{\text{FSR1}}$.

[#] Values specified by design but not tested

RESET TIMING (CONTINUED)

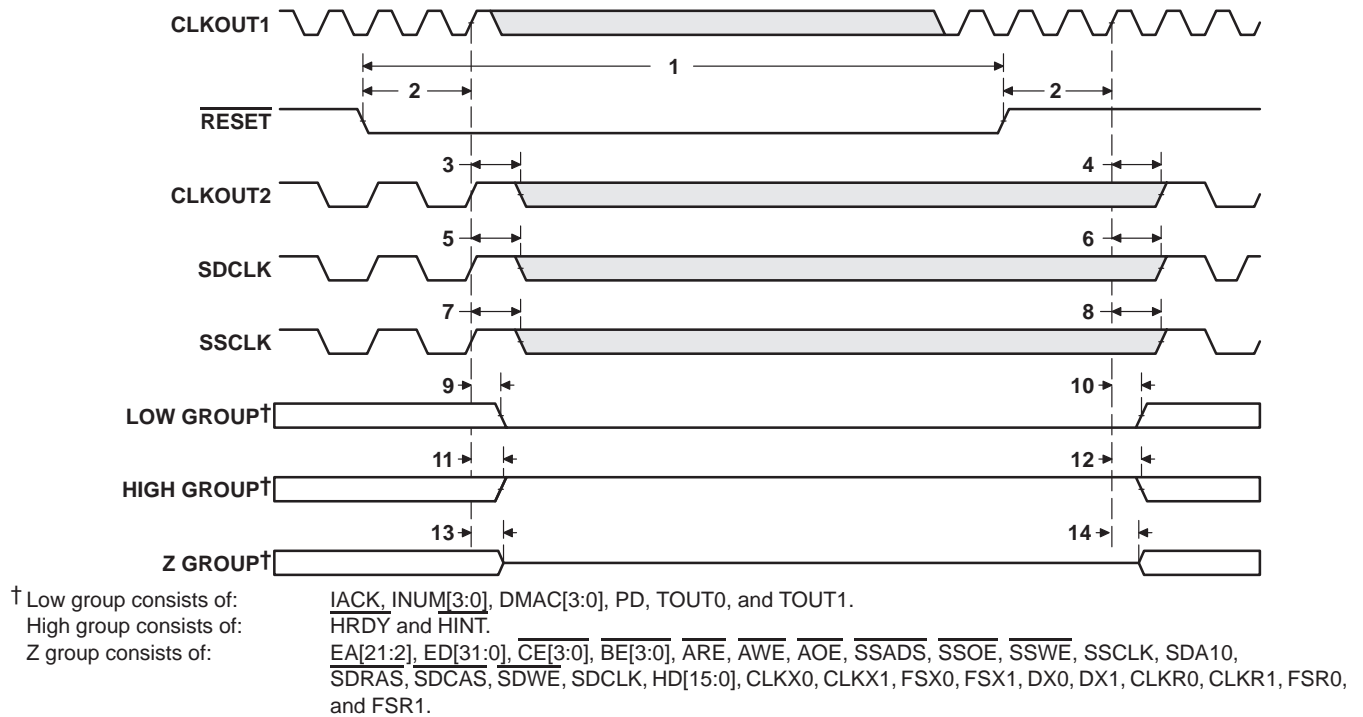


Figure 25. Reset Timing

EXTERNAL INTERRUPT/RESET TIMING

timing requirements for interrupt response cycles† (see Figure 26)

NO.			'C6701-150 'C6701-167	UNIT
			MIN MAX	
3	$t_{w(ILOW)}$	Width of the interrupt pulse low	2	CLKOUT1 cycles
4	$t_{w(IHIGH)}$	Width of the interrupt pulse high	2	CLKOUT1 cycles

† Interrupt signals are synchronized internally and are potentially recognized one cycle later if setup and hold times are violated. Thus, they can be connected to asynchronous inputs.

switching characteristics during interrupt response cycles (see Figure 26)

NO.	PARAMETER		'C6701-150 'C6701-167	UNIT
			MIN MAX	
1	$t_R(IACK)$	Response time, IACK high after EXT_INTx high	9‡	CLKOUT1 cycles
2	$t_R(ISFP)$	Response time, interrupt service fetch packet execution after EXT_INTx high	11‡	CLKOUT1 cycles
5	$t_d(CKO2L-IACKV)$	Delay time, CLKOUT2 low to IACK valid	0 10	ns
6	$t_d(CKO2L-INUMV)$	Delay time, CLKOUT2 low to INUM valid	0 10	ns
7	$t_d(CKO2L-INUMIV)$	Delay time, CLKOUT2 low to INUM invalid§	0 10	ns

‡ Add two CLKOUT1 cycles to this parameter if the interrupt is recognized during the high half of CLKOUT2

§ Values specified by design but not tested

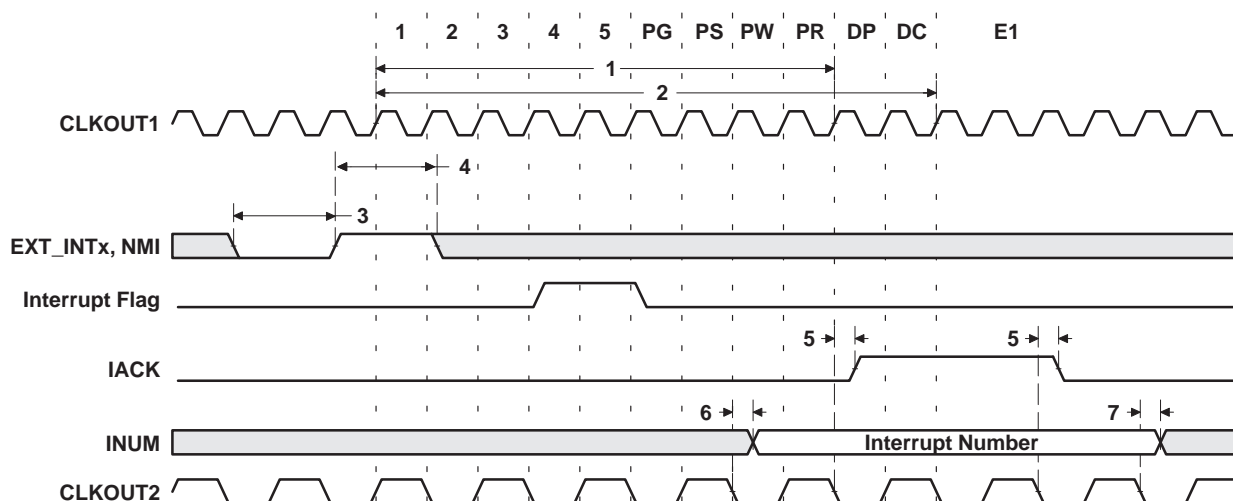


Figure 26. Interrupt Timing

HOST-PORT INTERFACE TIMING

timing requirements for host-port interface cycles^{†‡} (see Figure 27, Figure 28, Figure 29, and Figure 30)

NO.			'C6701-150 'C6701-167	UNIT
			MIN MAX	
1	$t_{su}(\text{SEL-HSTBL})$	Setup time, select signals [§] valid before $\overline{\text{HSTROBE}}$ low	1	ns
2	$t_h(\text{HSTBL-SEL})$	Hold time, select signals [§] valid after $\overline{\text{HSTROBE}}$ low	2	ns
3	$t_w(\text{HSTBL})$	Pulse duration, $\overline{\text{HSTROBE}}$ low	2	CLKOUT1 cycles
4	$t_w(\text{HSTBH})$	Pulse duration, $\overline{\text{HSTROBE}}$ high between consecutive accesses	2	CLKOUT1 cycles
10	$t_{su}(\text{SEL-HASL})$	Setup time, select signals [§] valid before $\overline{\text{HAS}}$ low	1	ns
11	$t_h(\text{HASL-SEL})$	Hold time, select signals [§] valid after $\overline{\text{HAS}}$ low	2	ns
12	$t_{su}(\text{HDV-HSTBH})$	Setup time, host data valid before $\overline{\text{HSTROBE}}$ high	1	ns
13	$t_h(\text{HSTBH-HDV})$	Hold time, host data valid after $\overline{\text{HSTROBE}}$ high	1	ns
14	$t_h(\text{HRDYL-HSTBL})$	Hold time, $\overline{\text{HSTROBE}}$ low after $\overline{\text{HRDY}}$ low. $\overline{\text{HSTROBE}}$ should not be inactivated until $\overline{\text{HRDY}}$ is active (low); otherwise, HPI writes will not complete properly.	1	ns

[†] $\overline{\text{HSTROBE}}$ refers to the following logical operation on $\overline{\text{HCS}}$, $\overline{\text{HDS1}}$, and $\overline{\text{HDS2}}$: $[\text{NOT}(\overline{\text{HDS1}} \text{ XOR } \overline{\text{HDS2}})] \text{ OR } \overline{\text{HCS}}$.

[‡] The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. $P = 1/\text{CPU clock frequency}$ in ns. For example, when running parts at 167 MHz, use $P = 6$ ns.

[§] Select signals include: $\text{HCNTRL}[1:0]$, $\overline{\text{HR}}/\overline{\text{W}}$, and $\overline{\text{HWWIL}}$.

switching characteristics during host-port interface cycles^{†‡} (see Figure 27, Figure 28, Figure 29, and Figure 30)

NO.	PARAMETER		'C6701-150 'C6701-167	UNIT
			MIN MAX	
5	$t_d(\text{HCS-HRDY})$	Delay time, $\overline{\text{HCS}}$ to $\overline{\text{HRDY}}^{\dagger\dagger}$	1 7	ns
6	$t_d(\text{HSTBL-HRDYH})$	Delay time, $\overline{\text{HSTROBE}}$ low to $\overline{\text{HRDY}}$ high [#]	3 12	ns
7	$t_{oh}(\text{HSTBL-HDLZ})$	Output hold time, HD low impedance after $\overline{\text{HSTROBE}}$ low for an HPI read	4	ns
8	$t_d(\text{HDV-HRDYL})$	Delay time, HD valid to $\overline{\text{HRDY}}$ low	$P - 2$ P	ns
9	$t_{oh}(\text{HSTBH-HDV})$	Output hold time, HD valid after $\overline{\text{HSTROBE}}$ high	3 12	ns
15	$t_d(\text{HSTBH-HDZH})$	Delay time, $\overline{\text{HSTROBE}}$ high to HD high impedance	3 12	ns
16	$t_d(\text{HSTBL-HDV})$	Delay time, $\overline{\text{HSTROBE}}$ low to HD valid	3 12	ns
17	$t_d(\text{HSTBH-HRDYH})$	Delay time, $\overline{\text{HSTROBE}}$ high to $\overline{\text{HRDY}}$ high [☆]	3 12	ns

[†] $\overline{\text{HSTROBE}}$ refers to the following logical operation on $\overline{\text{HCS}}$, $\overline{\text{HDS1}}$, and $\overline{\text{HDS2}}$: $[\text{NOT}(\overline{\text{HDS1}} \text{ XOR } \overline{\text{HDS2}})] \text{ OR } \overline{\text{HCS}}$.

[‡] The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. $P = 1/\text{CPU clock frequency}$ in ns. For example, when running parts at 167 MHz, use $P = 6$ ns.

^{††} $\overline{\text{HCS}}$ enables $\overline{\text{HRDY}}$, and $\overline{\text{HRDY}}$ is always low when $\overline{\text{HCS}}$ is high. The case where $\overline{\text{HRDY}}$ goes high when $\overline{\text{HCS}}$ falls indicates that HPI is busy completing a previous HPID write or READ with autoincrement.

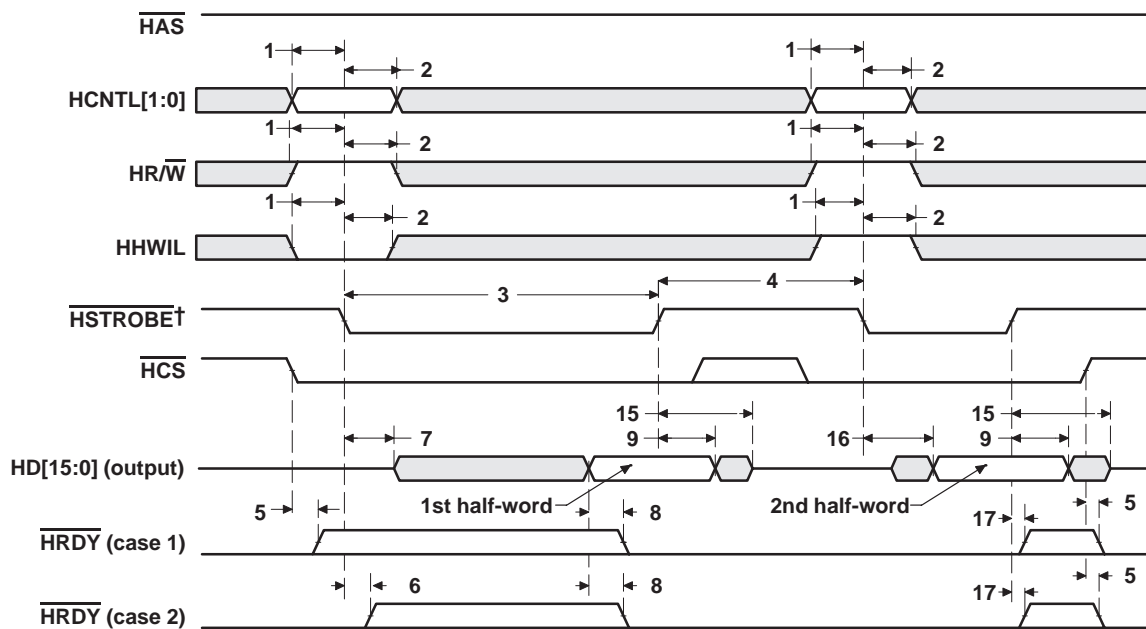
[#] This parameter is used during an HPID read. At the beginning of the first half-word transfer on the falling edge of $\overline{\text{HSTROBE}}$, the HPI sends the request to the DMA auxiliary channel, and $\overline{\text{HRDY}}$ remains high until the DMA auxiliary channel loads the requested data into HPID.

^{||} Values specified by design but not tested

[☆] This parameter is used after the second half-word of an HPID write or autoincrement read. $\overline{\text{HRDY}}$ remains low if the access is not an HPID write or autoincrement read. Reading or writing to HPIC or HPIC does not affect the $\overline{\text{HRDY}}$ signal.

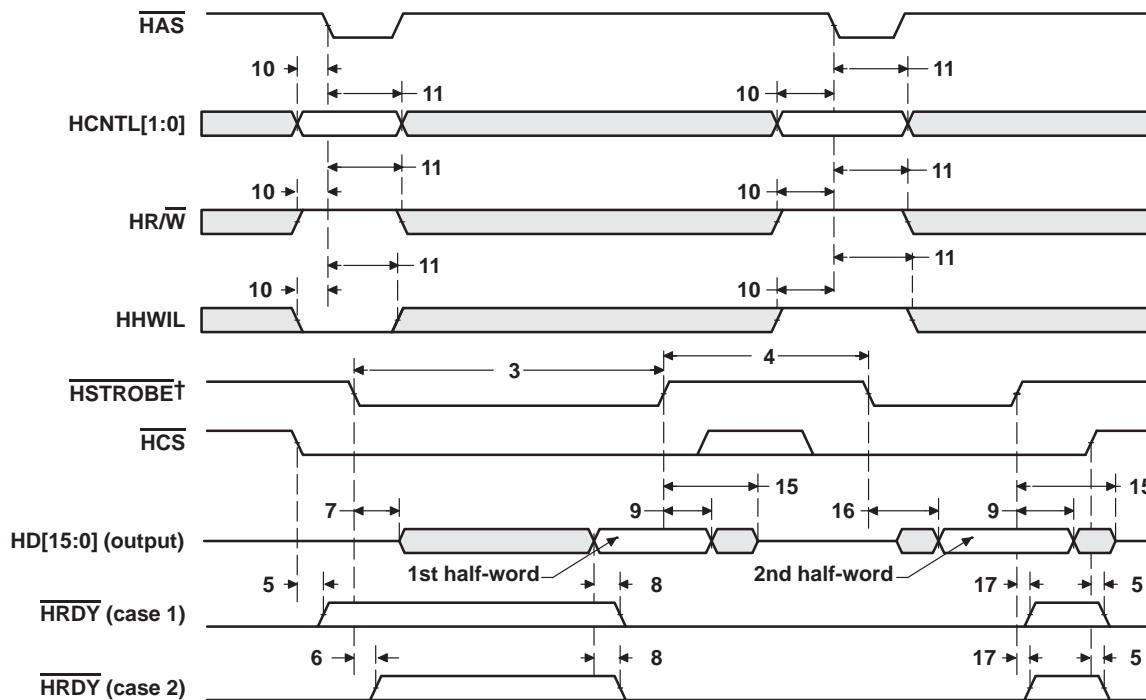
ADVANCE INFORMATION

HOST-PORT INTERFACE TIMING (CONTINUED)



† HSTROBE refers to the following logical operation on \overline{HCS} , $\overline{HDS1}$, and $\overline{HDS2}$: $[\text{NOT}(\overline{HDS1} \text{ XOR } \overline{HDS2})] \text{ OR } \overline{HCS}$.

Figure 27. HPI Read Timing (\overline{HAS} Not Used, Tied High)



† HSTROBE refers to the following logical operation on \overline{HCS} , $\overline{HDS1}$, and $\overline{HDS2}$: $[\text{NOT}(\overline{HDS1} \text{ XOR } \overline{HDS2})] \text{ OR } \overline{HCS}$.

Figure 28. HPI Read Timing (\overline{HAS} Used)

HOST-PORT INTERFACE TIMING (CONTINUED)

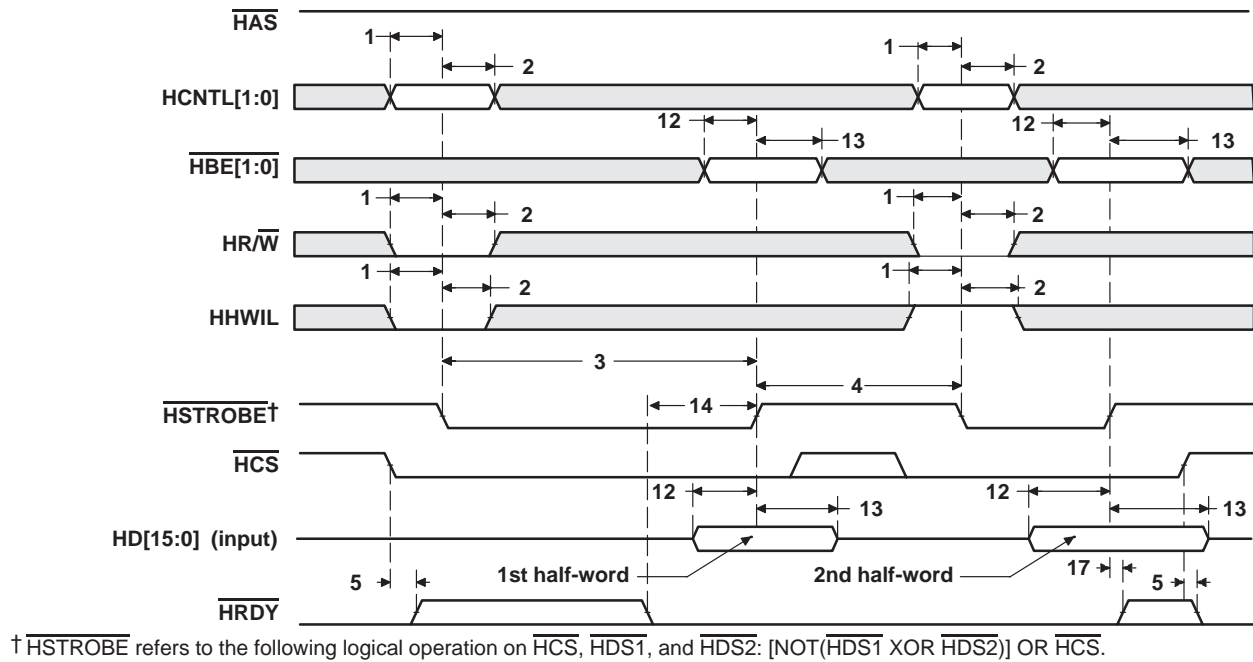


Figure 29. HPI Write Timing ($\overline{\text{HAS}}$ Not Used, Tied High)

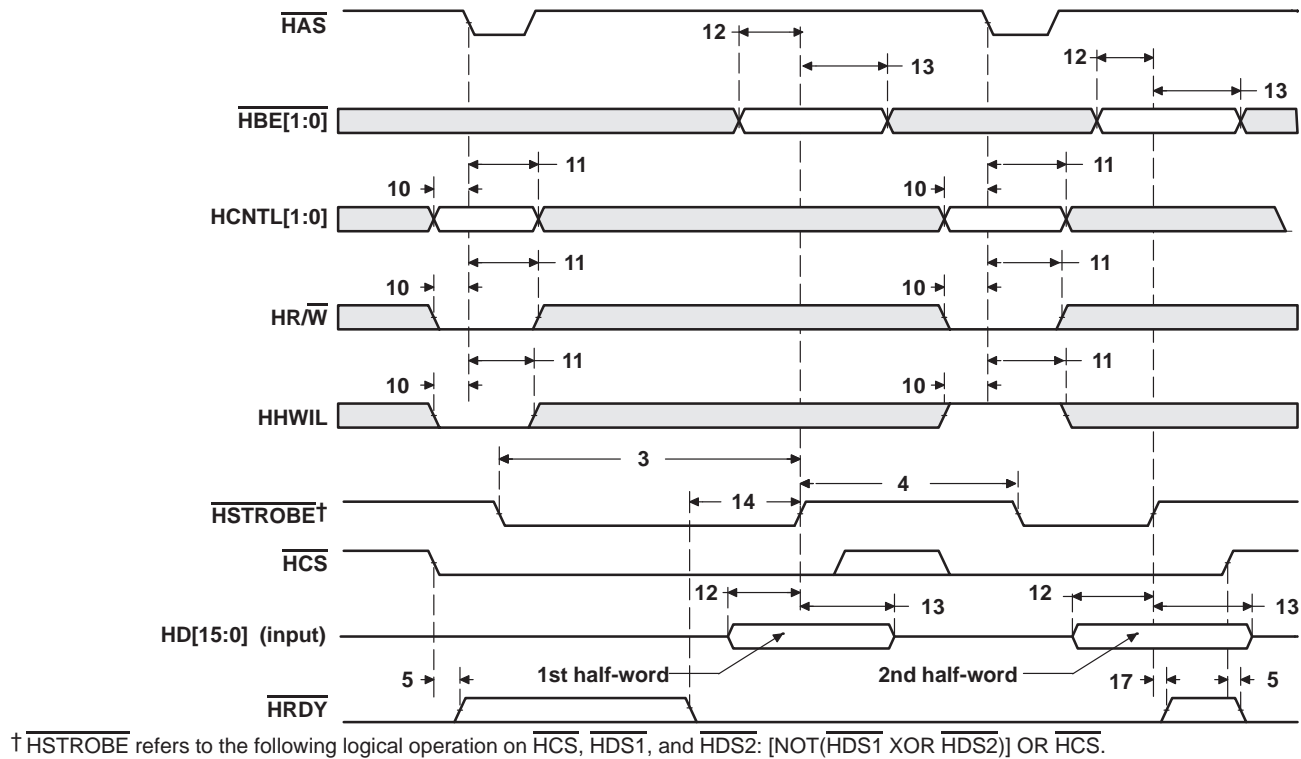


Figure 30. HPI Write Timing ($\overline{\text{HAS}}$ Used)

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MULTICHANNEL BUFFERED SERIAL PORT TIMING

timing requirements for McBSP† (see Figure 31)

NO.				'C6701-150 'C6701-167	UNIT
				MIN MAX	
2	$t_c(\text{CKRX})$	Cycle time, CLKR/X	CLKR/X ext	2	CLKOUT1 cycles
3	$t_w(\text{CKRX})$	Pulse duration, CLKR/X high or CLKR/X low	CLKR/X ext	4	ns
5	$t_{su}(\text{FRH-CKRL})$	Setup time, external FSR high before CLKR low	CLKR int	13	ns
			CLKR ext	4	
6	$t_h(\text{CKRL-FRH})$	Hold time, external FSR high after CLKR low	CLKR int	7	ns
			CLKR ext	3	
7	$t_{su}(\text{DRV-CKRL})$	Setup time, DR valid before CLKR low	CLKR int	10	ns
			CLKR ext	1	
8	$t_h(\text{CKRL-DRV})$	Hold time, DR valid after CLKR low	CLKR int	4	ns
			CLKR ext	4	
10	$t_{su}(\text{FXH-CKXL})$	Setup time, external FSX high before CLKX low	CLKX int	13	ns
			CLKX ext	4	
11	$t_h(\text{CKXL-FXH})$	Hold time, external FSX high after CLKX low	CLKX int	7	ns
			CLKX ext	3	

† CLKRP = CLKXP = FSRP = FSXP = 0. If polarity of any of the signals is inverted, then the timing references of that signal are also inverted.

MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

switching characteristics for McBSP†‡ (see Figure 31)

NO.	PARAMETER		'C6701-150 'C6701-167		UNIT
			MIN	MAX	
1	$t_d(\text{CKSH-CKRXH})$	Delay time, CLKS high to CLKR/X high for internal CLKR/X generated from CLKS input	4	15	ns
2	$t_c(\text{CKRX})$	Cycle time, CLKR/X	2§		CLKOUT1 cycles
3	$t_w(\text{CKRX})$	Pulse duration, CLKR/X high or CLKR/X low	$C - 1¶$	$C + 1¶$	ns
4	$t_d(\text{CKRH-FRV})$	Delay time, CLKR high to internal FSR valid	-2	4	ns
9	$t_d(\text{CKXH-FXV})$	Delay time, CLKX high to internal FSX valid	CLKX int	0	6
			CLKX ext	3	16
12	$t_{dis}(\text{CKXH-DXHZ})$	Disable time, DX high impedance following last data bit from CLKX high#	CLKX int	-2	4
			CLKX ext	3	16
13	$t_d(\text{CKXH-DXV})$	Delay time, CLKX high to DX valid. This is also specified by design but not tested to be the delay time for data to be low impedance on the first data bit.	CLKX int	-2	4
			CLKX ext	3	16
14	$t_d(\text{FXH-DXV})$	Delay time, FSX high to DX valid. This is also specified by design but not tested to be the delay time for data to be low impedance on the first data bit. ONLY applies when in data delay 0 (XDATDLY = 00b) mode.	FSX int	-2	4
			FSX ext	3	16

† CLKRP = CLKXP = FSRP = FSXP = 0. If polarity of any of the signals is inverted, then the timing references of that signal are also inverted.

‡ Minimum delay times also represent minimum output hold times.

§ The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. $P = 1/\text{CPU clock frequency}$ in ns. For example, when running parts at 167 MHz, use $P = 6$ ns.

¶ C = H or L

H = CLKX high pulse width = $(\text{CLKGDV}/2 + 1) * T$

L = CLKX low pulse width = $(\text{CLKGDV}/2) * T$

Values specified by design but not tested

ADVANCE INFORMATION

MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

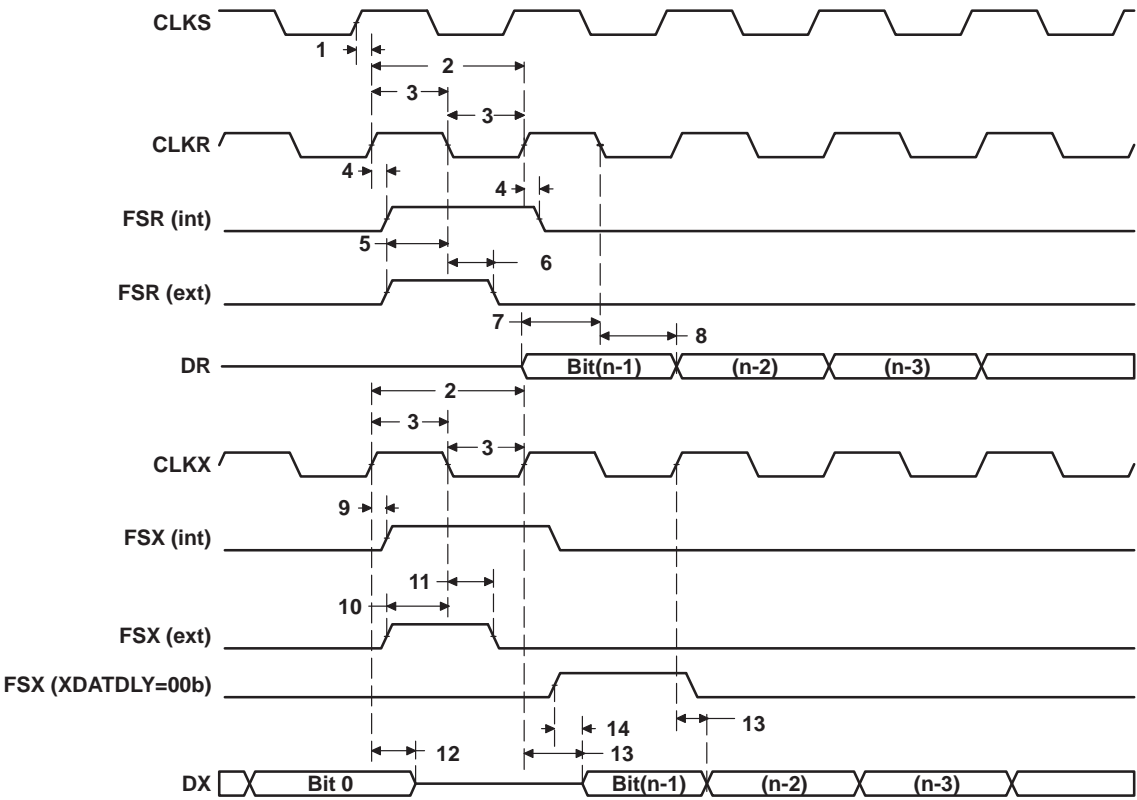


Figure 31. McBSP Timings

MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

timing requirements for FSR when GSYNC = 1 (see Figure 32)

NO.		'C6701-150 'C6701-167	UNIT
		MIN MAX	
1	$t_{su}(FRH-CKSH)$ Setup time, FSR high before CLKS high	4	ns
2	$t_h(CKSH-FRH)$ Hold time, FSR high after CLKS high	4	ns

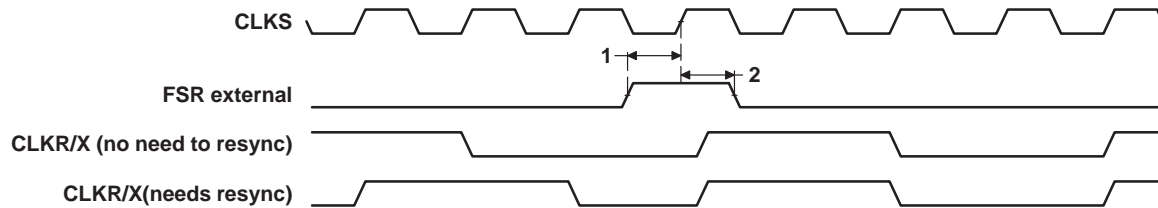


Figure 32. FSR Timing When GSYNC = 1

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MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

timing requirements for McBSP as SPI master or slave: CLKSTP = 10b, CLKXP = 0†‡ (see Figure 33)

NO.		'C6701-150 'C6701-167				UNIT
		MASTER		SLAVE		
		MIN	MAX	MIN	MAX	
4	t _{su} (DRV-CKXL) Setup time, DR valid before CLKX low	12		2 – 3P		ns
5	t _h (CKXL-DRV) Hold time, DR valid after CLKX low	4		5 + 3P		ns

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

switching characteristics for McBSP as SPI master or slave: CLKSTP = 10b, CLKXP = 0†‡ (see Figure 33)

NO.	PARAMETER		'C6701-150 'C6701-167				UNIT
			MASTER§		SLAVE		
			MIN	MAX	MIN	MAX	
1	t _h (CKXL-FXL)	Hold time, FSX low after CLKX low¶	T – 2	T + 2			ns
2	t _d (FXL-CKXH)	Delay time, FSX low to CLKX high#	L – 2	L + 2			ns
3	t _d (CKXH-DXV)	Delay time, CLKX high to DX valid This is also specified by design but not tested to be the delay time for data to be low impedance on the first data bit.	–2	3	3P + 4	5P + 17	ns
6	t _{dis} (CKXL-DXHZ)	Disable time, DX high impedance following last data bit from CLKX low	L – 2	L + 2			ns
7	t _{dis} (FXH-DXHZ)	Disable time, DX high impedance following last data bit from FSX high			P + 4	3P + 17	ns
8	t _d (FXL-DXV)	Delay time, FSX low to DX valid			2P + 4	4P + 17	ns

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

§ T = CLKX period = (1 + CLKGDV) * P; if CLKSM = 1, then P = 1/CPU clock frequency

= CLKX period = (1 + CLKGDV) * P_{clks}; if CLKSM = 0, then P_{clks} = CLKS period.

H = CLKX high pulse width = (CLKGDV/2 + 1) * T

L = CLKX low pulse width = (CLKGDV/2) * T

¶ FSRP = FSXP = 1. As a SPI master, FSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on FSX and FSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

FSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (CLKX).

|| Values specified by design but not tested

ADVANCE INFORMATION



MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

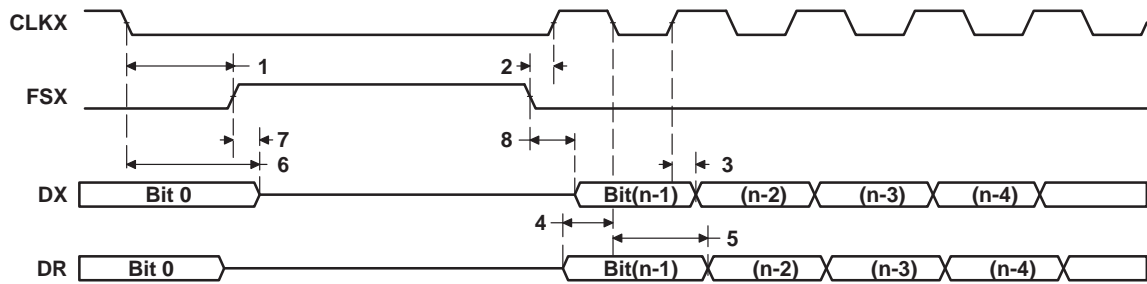


Figure 33. McBSP Timing as SPI Master or Slave: CLKSTP = 10b, CLKXP = 0

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MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

timing requirements for McBSP as SPI master or slave: CLKSTP = 11b, CLKXP = 0†‡ (see Figure 34)

NO.		'C6701-150 'C6701-167				UNIT
		MASTER		SLAVE		
		MIN	MAX	MIN	MAX	
4	t _{su} (DRV-CKXH) Setup time, DR valid before CLKX high	12		2 – 3P	ns	
5	t _h (CKXH-DRV) Hold time, DR valid after CLKX high	4		5 + 3P	ns	

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

switching characteristics for McBSP as SPI master or slave: CLKSTP = 11b, CLKXP = 0†‡ (see Figure 34)

NO.	PARAMETER		'C6701-150 'C6701-167				UNIT
			MASTER§		SLAVE		
			MIN	MAX	MIN	MAX	
1	t _h (CKXL-FXL)	Hold time, FSX low after CLKX low¶	L – 2	L + 2			ns
2	t _d (FXL-CKXH)	Delay time, FSX low to CLKX high#	T – 2	T + 2			ns
3	t _d (CKXL-DXV)	Delay time, CLKX low to DX valid	–2	3	3P + 4	5P + 17	ns
6	t _{dis} (CKXL-DXHZ)	Disable time, DX high impedance following last data bit from CLKX low	–2	3	3P + 4	5P + 17	ns
7	t _d (FXL-DXV)	Delay time, FSX low to DX valid	H – 2	H + 3	2P + 4	4P + 17	ns

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

§ T = CLKX period = (1 + CLKGDV) * P; if CLKSM = 1, then P = 1/CPU clock frequency

= CLKX period = (1 + CLKGDV) * P_clks; if CLKSM = 0, then P_clks = CLKS period.

H = CLKX high pulse width = (CLKGDV/2 + 1) * T

L = CLKX low pulse width = (CLKGDV/2) * T

¶ FSRP = FSXP = 1. As a SPI master, FSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on FSX and FSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

FSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (CLKX).

|| Values specified by design but not tested

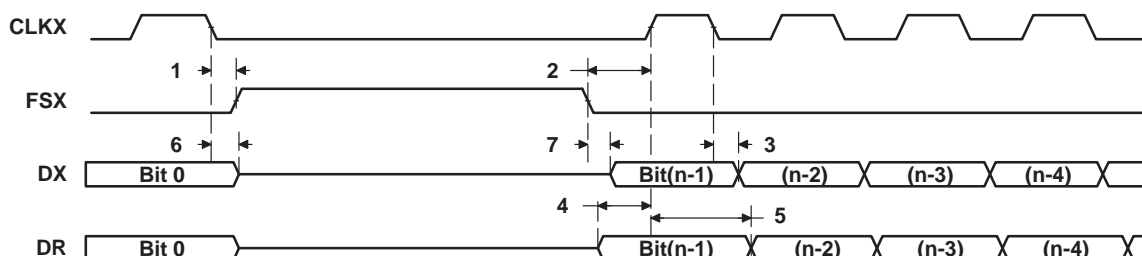


Figure 34. McBSP Timing as SPI Master or Slave: CLKSTP = 11b, CLKXP = 0

MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

timing requirements for McBSP as SPI master or slave: CLKSTP = 10b, CLKXP = 1†‡ (see Figure 35)

NO.		'C6701-150 'C6701-167				UNIT
		MASTER		SLAVE		
		MIN	MAX	MIN	MAX	
4	t _{su} (DRV-CKXH) Setup time, DR valid before CLKX high	12		2 – 3P		ns
5	t _h (CKXH-DRV) Hold time, DR valid after CLKX high	4		5 + 3P		ns

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

switching characteristics for McBSP as SPI master or slave: CLKSTP = 10b, CLKXP = 1†‡ (see Figure 35)

NO.	PARAMETER		'C6701-150 'C6701-167				UNIT
			MASTER§		SLAVE		
			MIN	MAX	MIN	MAX	
1	t _h (CKXH-FXL)	Hold time, FSX low after CLKX high¶	T – 2	T + 2			ns
2	t _d (FXL-CKXL)	Delay time, FSX low to CLKX low [#]	H – 2	H + 2			ns
3	t _d (CKXL-DXV)	Delay time, CLKX low to DX valid This is also specified by design but not tested to be the delay time for data to be low impedance on the first data bit.	–2	3	3P + 4	5P + 17	ns
6	t _{dis} (CKXH-DXHZ)	Disable time, DX high impedance following last data bit from CLKX high	H – 2	H + 2			ns
7	t _{dis} (FXH-DXHZ)	Disable time, DX high impedance following last data bit from FSX high			P + 4	3P + 17	ns
8	t _d (FXL-DXV)	Delay time, FSX low to DX valid			2P + 4	4P + 17	ns

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

§ T = CLKX period = (1 + CLKGDV) * P; if CLKSM = 1, then P = 1/CPU clock frequency
= CLKX period = (1 + CLKGDV) * P_clks; if CLKSM = 0, then P_clks = CLKS period.

H = CLKX high pulse width = (CLKGDV/2 + 1) * T

L = CLKX low pulse width = (CLKGDV/2) * T

¶ FSRP = FSXP = 1. As a SPI master, FSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on FSX and FSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

FSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (CLKX).

|| Values specified by design but not tested

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MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

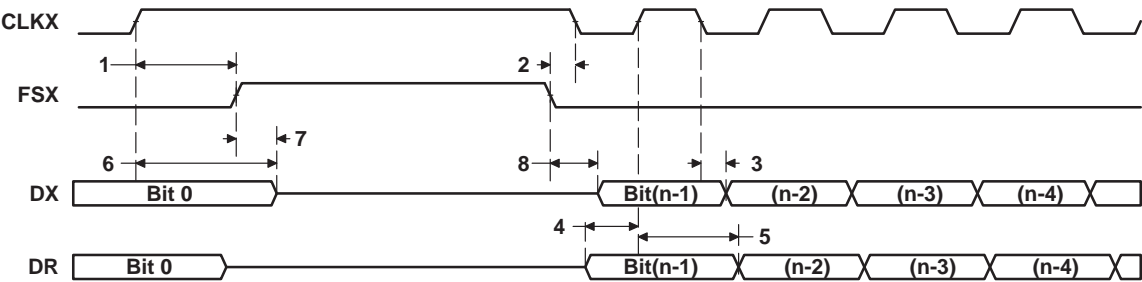


Figure 35. McBSP Timing as SPI Master or Slave: CLKSTP = 10b, CLKXP = 1

MULTICHANNEL BUFFERED SERIAL PORT TIMING (CONTINUED)

timing requirements for McBSP as SPI master or slave: CLKSTP = 11b, CLKXP = 1†‡ (see Figure 36)

NO.		'C6701-150 'C6701-167				UNIT
		MASTER		SLAVE		
		MIN	MAX	MIN	MAX	
4	t _{su} (DRV-CKXL) Setup time, DR valid before CLKX low	12		2 – 3P		ns
5	t _h (CKXL-DRV) Hold time, DR valid after CLKX low	4		5 + 3P		ns

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

switching characteristics for McBSP as SPI master or slave: CLKSTP = 11b, CLKXP = 1†‡ (see Figure 36)

NO.	PARAMETER		'C6701-150 'C6701-167				UNIT
			MASTER§		SLAVE		
			MIN	MAX	MIN	MAX	
1	t _h (CKXH-FXL)	Hold time, FSX low after CLKX high¶	H – 2	H + 2			ns
2	t _d (FXL-CKXL)	Delay time, FSX low to CLKX low#	T – 2	T			ns
3	t _d (CKXH-DXV)	Delay time, CLKX high to DX valid	–2	3	3P + 4	5P + 17	ns
6	t _{dis} (CKXH-DXHZ)	Disable time, DX high impedance following last data bit from CLKX high	–2	3	3P + 4	5P + 17	ns
7	t _d (FXL-DXV)	Delay time, FSX low to DX valid	L – 2	L + 3	2P + 4	4P + 17	ns

† The effects of internal clock jitter are included at test. There is no need to adjust timing numbers for internal clock jitter. P = 1/CPU clock frequency in ns. For example, when running parts at 167 MHz, use P = 6 ns.

‡ For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

§ T = CLKX period = (1 + CLKGDV) * P; if CLKSM = 1, then P = 1/CPU clock frequency
= CLKX period = (1 + CLKGDV) * P_clks; if CLKSM = 0, then P_clks = CLKS period.

H = CLKX high pulse width = (CLKGDV/2 + 1) * T

L = CLKX low pulse width = (CLKGDV/2) * T

¶ FSRP = FSXP = 1. As a SPI master, FSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on FSX and FSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

FSX should be low before the rising edge of clock to enable slave devices and then begin a SPI transfer at the rising edge of the master clock (CLKX).

|| Values specified by design but not tested

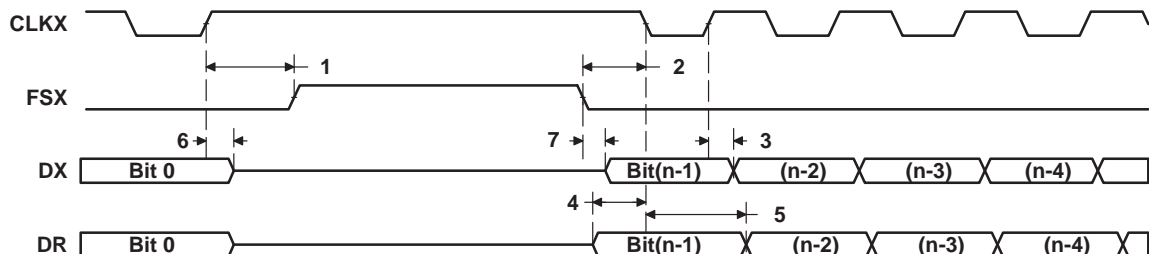


Figure 36. McBSP Timing as SPI Master or Slave: CLKSTP = 11b, CLKXP = 1

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DMAC, TIMER, POWER-DOWN TIMING

switching characteristics for DMAC outputs (see Figure 37)

NO.	PARAMETER	'C6701-150 'C6701-167		UNIT
		MIN	MAX	
1	$t_d(\text{CKO1H-DMACV})$ Delay time, CLKOUT1 high to DMAC valid	3	8	ns

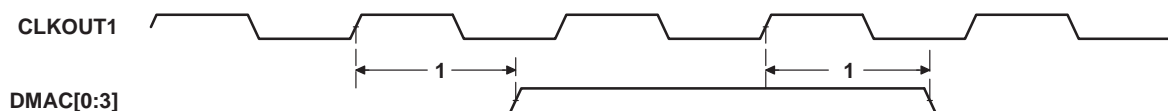


Figure 37. DMAC Timing

timing requirements for timer inputs (see Figure 38)

NO.	PARAMETER	'C6701-150 'C6701-167		UNIT
		MIN	MAX	
1	$t_w(\text{TINPH})$ Pulse duration, TINP high	2		CLKOUT1 cycles

switching characteristics for timer outputs (see Figure 38)

NO.	PARAMETER	'C6701-150 'C6701-167		UNIT
		MIN	MAX	
2	$t_d(\text{CKO1H-TOUTV})$ Delay time, CLKOUT1 high to TOUT valid	3	9	ns

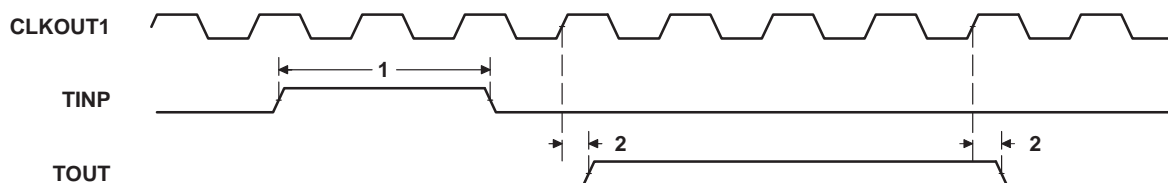


Figure 38. Timer Timing

switching characteristics for power-down outputs (see Figure 39)

NO.	PARAMETER	'C6701-150 'C6701-167		UNIT
		MIN	MAX	
1	$t_d(\text{CKO1H-PDV})$ Delay time, CLKOUT1 high to PD valid	3	5	ns

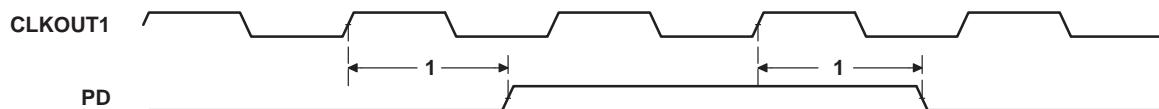
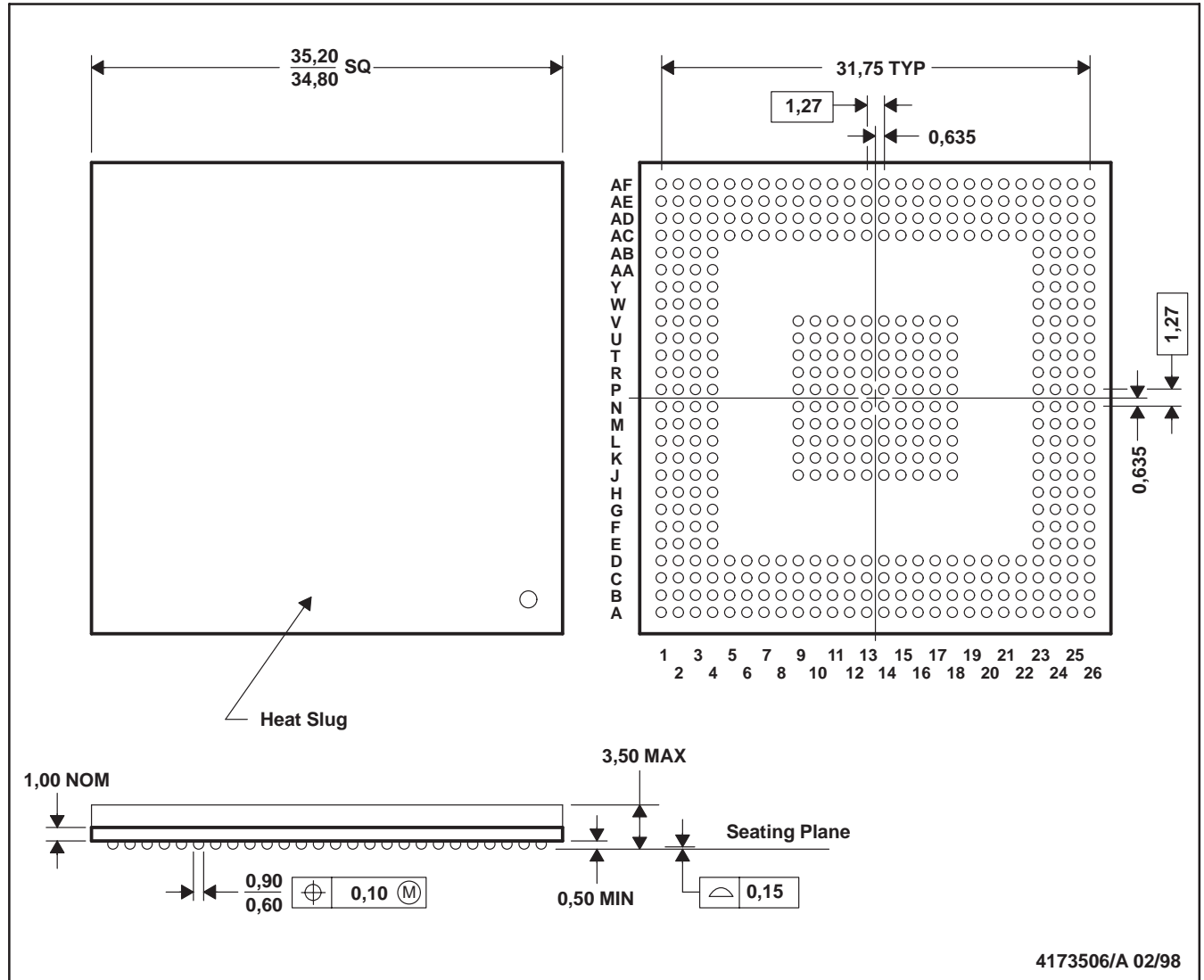


Figure 39. Power-Down Timing

MECHANICAL DATA

GJC (S-PBGA-N452)

PLASTIC BALL GRID ARRAY



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Thermally enhanced plastic package with heat slug (HSL).
 D. Falls within JEDEC MO-151/BAR-2
 E. Flip chip application only.

thermal resistance characteristics (S-PBGA package)

NO		°C/W	Air Flow LFPM†
1	R θ_{JC} Junction-to-case	0.94	N/A
2	R θ_{JA} Junction-to-free air	11.11	0
3	R θ_{JA} Junction-to-free air	9.61	100
4	R θ_{JA} Junction-to-free air	8.24	250
5	R θ_{JA} Junction-to-free air	7.10	500

† LFPM = Linear Feet Per Minute

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